



Report No.: RZA2010-0732



OET 65

TEST REPORT

Product Name	USB Stick
Model	K3570-Z
FCC ID	Q78-K3570-Z
Client	ZTE CORPORATION

TA Technology (Shanghai) Co., Ltd.



GENERAL SUMMARY

Product Name	USB Stick	Model	K3570-Z
FCC ID	Q78-K3570-Z		
Report No.	RZA2010-0732		
Client	ZTE CORPORATION		
Manufacturer	ZTE CORPORATION		
Reference Standard(s)	<p>IEEE Std C95.1, 1999: IEEE Standard for Safety Levels with Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3 kHz to 300 GHz.</p> <p>SUPPLEMENT C Edition 01-01 to OET BULLETIN 65 Edition 97-01 June 2001 including DA 02-1438, published June 2002: Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields Additional Information for Evaluation Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions</p> <p>KDB 447498 D02:2009-11-13</p>		
Conclusion	<p>This portable wireless equipment has been measured in all cases requested by the relevant standards. Test results in Chapter 7 of this test report are below limits specified in the relevant standards.</p> <p>General Judgment: Pass</p> <p style="text-align: right;">(Stamp) Date of issue: May 12th, 2010</p>		
Comment	The test result only responds to the measured sample.		

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TABLE OF CONTENT

1. General Information	5
1.1. Notes of the test report	5
1.2. Testing laboratory	5
1.3. Applicant Information	6
1.4. Manufacturer Information	6
1.5. InGeneral information	7
1.6. Test Date	9
2. Operational Conditions during Test	10
2.1. General description of test procedures	10
2.2. GSM Test Configuration	10
2.3. Position of module in Portable devices	11
2.4. Picture of host product	12
3. SAR Measurements System Configuration	13
3.1. SAR Measurement Set-up	13
3.2. Dasy4 E-field Probe System	14
3.2.1. EX3DV4 Probe Specification	14
3.2.2. E-field Probe Calibration	15
3.3. Other Test Equipment	15
3.3.1. Device Holder for Transmitters	15
3.3.2. Phantom	16
3.4. Scanning procedure	16
3.5. Data Storage and Evaluation	18
3.5.1. Data Storage	18
3.5.2. Data Evaluation by SEMCAD	18
3.6. System check	21
3.7. Equivalent Tissues	22
4. Laboratory Environment	22
5. Characteristics of the Test	23
5.1. Applicable Limit Regulations	23
5.2. Applicable Measurement Standards	23
6. Conducted Output Power Measurement	24
6.1. Summary	24
6.2. Conducted Power Results	24
7. Test Results	26
7.1. Dielectric Performance	26
7.2. System Check	26
7.3. Summary of Measurement Results	27
7.3.1. GSM 850(GPRS/EGPRS)	27
7.3.2. GSM 1900(GPRS/EGPRS)	29
8. Measurement Uncertainty	31
9. Main Test Instruments	32
ANNEX A: Test Layout	33
ANNEX B: System Check Results	35

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA2010-0732

Page 4 of 73

ANNEX C: Graph Results	37
ANNEX D: Probe Calibration Certificate	40
ANNEX E: D835V2 Dipole Calibration Certificate	49
ANNEX F: D1900V2 Dipole Calibration Certificate	58
ANNEX G: DAE4 Calibration Certificate.....	67
ANNEX H: The EUT Appearances and Test Configuration.....	72

1. General Information

1.1. Notes of the test report

TA Technology (Shanghai) Co., Ltd. guarantees the reliability of the data presented in this test report, which is the results of measurements and tests performed for the items under test on the date and under the conditions stated in this test report and is based on the knowledge and technical facilities available at TA Technology (Shanghai) Co., Ltd. at the time of execution of the test.

TA Technology (Shanghai) Co., Ltd. is liable to the client for the maintenance by its personnel of the confidentiality of all information related to the items under test and the results of the test. This report only refers to the item that has undergone the test.

This report standalone does not constitute or imply by its own an approval of the product by the certification Bodies or competent Authorities. This report cannot be used partially or in full for publicity and/or promotional purposes without previous written approval of **TA Technology (Shanghai) Co., Ltd.** and the Accreditation Bodies, if it applies.

1.2. Testing laboratory

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TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0732

Page 7 of 73

1.5. InGeneral information

Device type :	portable device		
Exposure category:	uncontrolled environment / general population		
Name of EUT:	USB Stick		
IMEI :	359592030002698		
Device operating configurations :			
Operating mode(s):	GSM850; (tested) GSM1900; (tested)		
Test modulation:	(GSM)GMSK		
GPRS multislots class :	10		
EGPRS multislots class:	12		
Maximum Output Power:	GSM850	32.53 dBm	
	GSM1900	29.53 dBm	
Maximum localized SAR _{1g} :	GSM850	1.07 W/kg	
	GSM1900	1.13 W/kg	
Operating frequency range(s)	Band	Tx (MHz)	Rx (MHz)
	GSM850	824.2 ~ 848.8	869.2 ~ 893.8
	GSM1900	1850.2 ~ 1909.8	1930.2 ~ 1989.8
Power class	GSM 850: 4, tested with power level 5		
	GSM 1900: 1, tested with power level 0		
Test channel (Low –Middle –High)	128 -190 - 251	(GSM850) (tested)	
	512 - 661 - 810	(GSM1900) (tested)	
Hardware version:	P680A8-1.0.1		
Software version:	BD_P680A8V1.0.0B03		
Antenna type:	Internal antenna		
Used host products:	IBM T61		

Equipment Under Test (EUT) is a USB Stick with internal antenna. During SAR test of the EUT, it was connected to a portable computer. SAR is tested for the EUT respectively for GSM 850 and GSM1900. The EUT have GPRS (class 10) and EGPRS (class 12) functions. The measurements were performed in combination with the host product (IBM T61). IBM T61 laptop has horizontal and vertical USB slots.

As the applicant of the below model, [ZTE Corporation] declares that the product,

[K3570-Z]
[ZTE Corporation]

is the variant of the initial certified product,

[K3570-Z]
[ZTE Corporation]

SOFTWARE MODIFICATIONS:

Protocol Stack changes: NO
MMS/STK changes: NO
JAVA changes: NO

HARDWARE MODIFICATION:

Band changes: NO
Power Amplifier changes: NO
Antenna changes: NO
PCB Layout changes: NO
Components on PCB changes: NO
LCD changes: NO
Speaker changes: NO
Camera changes: NO
Vibrator changes: NO
Bluetooth changes: NO
Other changes: NO

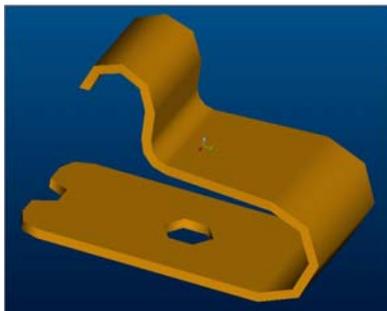
MECHANICAL MODIFICATIONS:

Use new metal front/back cover or keypad: NO

Other changes detailed:

1. Adding a bump on antenna contact

Before:

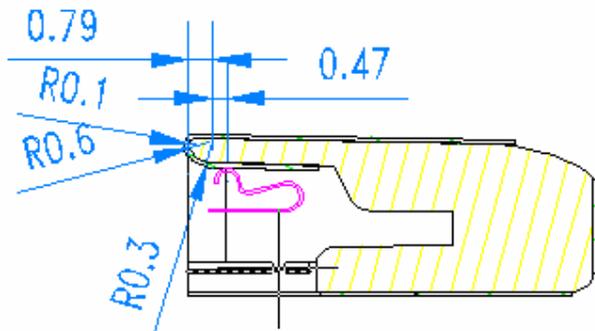


After:

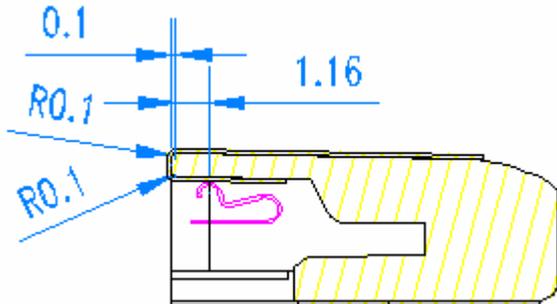


2. Antenna carrier improve

Before:



After:



The initial model of K3570-Z test report number is RZA2010-0233.

The sample undergoing test was selected by the Client.

Components list please refer to documents of the manufacturer.

1.6. Test Date

The test is performed on May 11, 2010.

2. Operational Conditions during Test

2.1. General description of test procedures

Connection to the EUT is established via air interface with E5515C, and the EUT is set to maximum output power by E5515C. The antenna connected to the output of the base station simulator shall be placed at least 50 cm away from the EUT. The signal transmitted by the simulator to the antenna feeding point shall be lower than the output power level of the EUT by at least 30 dB.

Since the EUT only has the data transfer function, but does not have the voice transfer function, the tests in the band of GSM 850 and GSM 1900 are performed in the mode of GPRS and EGPRS. The measurements were performed in combination with the host product (IBM T61). IBM T61 laptop has horizontal and vertical USB slots.

2.2. GSM Test Configuration

For the body SAR tests for GSM 850, GSM 1900, a communication link is set up with a System Simulator (SS) by air link. The EUT is commanded to operate at maximum transmitting power. Since the EUT only has the data transfer function, but does not have the speech transfer function. The tests in the band of GSM 850, GSM 1900 are only performed in the mode of GPRS and EGPRS. The GPRS class is 10 for this EUT; it has at most 2 timeslot in uplink. The EGPRS class is 12 for this EUT; it has at most 4 timeslot in uplink.

According to specification 3GPP TS 51.010, the maximum power of the GSM can do the power reduction for the multi-slot. The allowed power reduction in the multi-slot configuration is as following:

Table 1: The allowed power reduction in the multi-slot configuration

Number of timeslots in uplink assignment	Permissible nominal reduction of maximum output power,(dB)
1	0
2	0 to 3,0
3	1,8 to 4,8
4	3,0 to 6,0

2.3. Position of module in Portable devices

The measurements were performed in combination with the host product (IBM T61). IBM T61 laptop has horizontal and vertical USB slots.

A test distance of 5mm or less, according to KDB 447498 D02, should be considered for the orientation that can satisfy such requirements.

For each channel, the EUT is tested at the following 4 test positions:

- Test Position 1: The EUT is connected to the portable computer with horizontal USB slot. The back side of the EUT towards the bottom of the flat phantom. (ANNEX H Picture 6)
- Test Position 2: The EUT is connected to the portable computer through a 19 cm USB cable. The front side of the EUT towards the bottom of the flat phantom.
- Test Position 3: The EUT is connected to the portable computer through a 19 cm USB cable. The left side of the EUT towards the bottom of the flat phantom.
- Test Position 4: The EUT is connected to the portable computer with vertical USB slot. The right side of the EUT towards the bottom of the flat phantom. (ANNEX H Picture 7)

2.4. Picture of host product

During the test, IBM T61 laptop was used as an assistant to help to setup communication. (See Picture 1)



Picture 1-a: IBM T61 Close



Picture 1-b: IBM T61 Open



Picture 1-c: IBM T61 with horizontal USB slot



Picture 1-d: IBM T61 with vertical USB slot



Picture 1-e: a 19 cm USB cable

Picture 1: Computer as a test assistant

3. SAR Measurements System Configuration

3.1. SAR Measurement Set-up

The DASY4 system for performing compliance tests consists of the following items:

- A standard high precision 6-axis robot (Stäubli RX family) with controller and software. An arm extension for accommodating the data acquisition electronics (DAE).
- A dosimetric probe, i.e. an isotropic E-field probe optimized and calibrated for usage in tissue simulating liquid. The probe is equipped with an optical surface detector system.
- A data acquisition electronic (DAE) which performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. The unit is battery powered with standard or rechargeable batteries. The signal is optically transmitted to the EOC.
- A unit to operate the optical surface detector which is connected to the EOC.
- The Electro-Optical Coupler (EOC) performs the conversion from the optical into a digital electric signal of the DAE. The EOC is connected to the DASY4 measurement server.
- The DASY4 measurement server, which performs all real-time data evaluation for field measurements and surface detection, controls robot movements and handles safety operation. A computer operating Windows 2003
- DASY4 software and SEMCAD data evaluation software.
- Remote control with teach panel and additional circuitry for robot safety such as warning lamps, etc.
- The generic twin phantom enabling the testing of left-hand and right-hand usage.
- The device holder for handheld mobile phones.
- Tissue simulating liquid mixed according to the given recipes.
- System validation dipoles allowing to validate the proper functioning of the system.

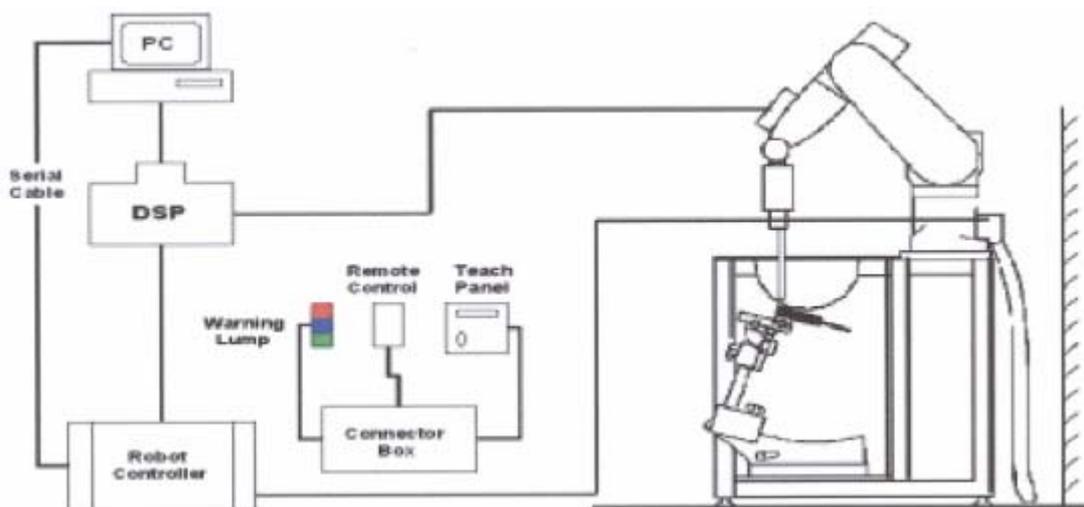


Figure 1. SAR Lab Test Measurement Set-up

3.2. Dasy4 E-field Probe System

The SAR measurements were conducted with the dosimetric probe EX3DV4 (manufactured by SPEAG), designed in the classical triangular configuration and optimized for dosimetric evaluation.

3.2.1. EX3DV4 Probe Specification

Construction	Symmetrical design with triangular core Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., DGBE)
Calibration	Basic Broad Band Calibration in air Conversion Factors (CF) for HSL 900 and HSL 1750 Additional CF for other liquids and frequencies upon request
Frequency	10 MHz to > 6 GHz Linearity: ± 0.2 dB (30 MHz to 6 GHz)
Directivity	± 0.3 dB in HSL (rotation around probe axis) ± 0.5 dB in tissue material (rotation normal to probe axis)
Dynamic Range	10 μ W/g to > 100 mW/g Linearity: ± 0.2 dB (noise: typically < 1 μ W/g)
Dimensions	Overall length: 330 mm (Tip: 20 mm) Tip diameter: 2.5 mm (Body: 12 mm) Typical distance from probe tip to dipole centers: 1 mm
Application	High precision dosimetric measurements in any exposure scenario (e.g., very strong gradient fields). Only probe which enables compliance testing for frequencies up to 6 GHz with precision of better 30%.



Figure 2. EX3DV4 E-field Probe



Figure 3. EX3DV4 E-field probe

3.2.2. E-field Probe Calibration

Each probe is calibrated according to a dosimetric assessment procedure with accuracy better than $\pm 10\%$. The spherical isotropy was evaluated and found to be better than $\pm 0.25\text{dB}$. The sensitivity parameters (NormX, NormY, NormZ), the diode compression parameter (DCP) and the conversion factor (ConvF) of the probe are tested.

The free space E-field from amplified probe outputs is determined in a test chamber. This is performed in a TEM cell for frequencies below 1 GHz, and in a wave guide above 1 GHz for free space. For the free space calibration, the probe is placed in the volumetric center of the cavity and at the proper orientation with the field. The probe is then rotated 360 degrees.

E-field temperature correlation calibration is performed in a flat phantom filled with the appropriate simulated brain tissue. The measured free space E-field in the medium correlates to temperature rise in a dielectric medium. For temperature correlation calibration a RF transparent thermistor-based temperature probe is used in conjunction with the E-field probe.

$$\text{SAR} = C \frac{\Delta T}{\Delta t}$$

Where: Δt = Exposure time (30 seconds),
C = Heat capacity of tissue (brain or muscle),
 ΔT = Temperature increase due to RF exposure.
Or

$$\text{SAR} = \frac{|E|^2 \sigma}{\rho}$$

Where:
 σ = Simulated tissue conductivity,
 ρ = Tissue density (kg/m³).

3.3. Other Test Equipment

3.3.1. Device Holder for Transmitters

Construction: Simple but effective and easy-to-use extension for Mounting Device that facilitates the testing of larger devices according to IEC 62209-2 (e.g., laptops, cameras, etc.) It is lightweight and fits easily on the upper part of the Mounting Device in place of the phone positioner. The extension is fully compatible with the Twin SAM, ELI4 and SAM v6.0 Phantoms.

Material: POM, Acrylic glass, Foam

3.3.2. Phantom

The Generic Twin Phantom is constructed of a fiberglass shell integrated in a wooden Figure. The shape of the shell is based on data from an anatomical study designed to determine the maximum exposure in at least 90% of all users. It enables the dosimetric evaluation of left and right hand phone usage as well as body mounted usage at the flat phantom region. A cover prevents the evaporation of the liquid. Reference markings on the Phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot.

Shell Thickness	2±0.1 mm
Filling Volume	Approx. 20 liters
Dimensions	810 x 1000 x 500 mm (H x L x W)
Available	Special



Figure 4. Generic Twin Phantom

3.4. Scanning procedure

The DASY4 installation includes predefined files with recommended procedures for measurements and validation. They are read-only document files and destined as fully defined but unmeasured masks. All test positions (head or body-worn) are tested with the same configuration of test steps differing only in the grid definition for the different test positions.

- The "reference" and "drift" measurements are located at the beginning and end of the batch process. They measure the field drift at one single point in the liquid over the complete procedure. The indicated drift is mainly the variation of the DUT's output power and should vary max. ± 5 %.
- The "surface check" measurement tests the optical surface detection system of the DASY4 system by repeatedly detecting the surface with the optical and mechanical surface detector and comparing the results. The output gives the detecting heights of both systems, the difference between the two systems and the standard deviation of the detection repeatability. Air bubbles or refraction in the liquid due to separation of the sugar-water mixture gives poor repeatability (above ± 0.1mm). To prevent wrong results tests are only executed when the liquid is free of air bubbles. The difference between the optical surface detection and the actual surface depends on the probe and is specified with each probe. (It does not depend on the surface reflectivity or the probe angle to the surface within ± 30°.)

- Area Scan

The Area Scan is used as a fast scan in two dimensions to find the area of high field values before running a detailed measurement around the hot spot. Before starting the area scan a grid spacing of 10 mm x 10 mm is set. During the scan the distance of the probe to the phantom remains

unchanged.

After finishing area scan, the field maxima within a range of 2 dB will be ascertained.

- **Zoom Scan**

Zoom Scans are used to estimate the peak spatial SAR values within a cubic averaging volume containing 1 g and 10 g of simulated tissue. The default Zoom Scan is done by 7x7x7 points within a cube whose base is centered around the maxima found in the preceding area scan.

- **Spatial Peak Detection**

The procedure for spatial peak SAR evaluation has been implemented and can determine values of masses of 1g and 10g, as well as for user-specific masses. The DASY4 system allows evaluations that combine measured data and robot positions, such as:

- maximum search
- extrapolation
- boundary correction
- peak search for averaged SAR

During a maximum search, global and local maxima searches are automatically performed in 2-D after each Area Scan measurement with at least 6 measurement points. It is based on the evaluation of the local SAR gradient calculated by the Quadratic Shepard's method. The algorithm will find the global maximum and all local maxima within -2 dB of the global maxima for all SAR distributions.

Extrapolation routines are used to obtain SAR values between the lowest measurement points and the inner phantom surface. The extrapolation distance is determined by the surface detection distance and the probe sensor offset. Several measurements at different distances are necessary for the extrapolation. Extrapolation routines require at least 10 measurement points in 3-D space.

They are used in the Zoom Scan to obtain SAR values between the lowest measurement points and the inner phantom surface. The routine uses the modified Quadratic Shepard's method for extrapolation. For a grid using 7x7x7 measurement points with 5mm resolution amounting to 343 measurement points, the uncertainty of the extrapolation routines is less than 1% for 1g and 10g cubes.

- A Z-axis scan measures the total SAR value at the x-and y-position of the maximum SAR value found during the cube 7x7x7 scan. The probe is moved away in z-direction from the bottom of the SAM phantom in 5mm steps.

3.5. Data Storage and Evaluation

3.5.1. Data Storage

The DASY4 software stores the acquired data from the data acquisition electronics as raw data (in microvolt readings from the probe sensors), together with all necessary software parameters for the data evaluation (probe calibration data, liquid parameters and device frequency and modulation data) in measurement files with the extension ".DA4". The software evaluates the desired unit and format for output each time the data is visualized or exported. This allows verification of the complete software setup even after the measurement and allows correction of incorrect parameter settings. For example, if a measurement has been performed with a wrong crest factor parameter in the device setup, the parameter can be corrected afterwards and the data can be re-evaluated.

The measured data can be visualized or exported in different units or formats, depending on the selected probe type ([V/m], [A/m], [°C], [mW/g], [mW/cm²], [dBrel], etc.). Some of these units are not available in certain situations or show meaningless results, e.g., a SAR output in a lossless media will always be zero. Raw data can also be exported to perform the evaluation with other software packages.

3.5.2. Data Evaluation by SEMCAD

The SEMCAD software automatically executes the following procedures to calculate the field units from the microvolt readings at the probe connector. The parameters used in the evaluation are stored in the configuration modules of the software:

Probe parameters:	- Sensitivity	Normi, a _{i0} , a _{i1} , a _{i2}
	- Conversion factor	ConvF _i
	- Diode compression point	Dcp _i
Device parameters:	- Frequency	f
	- Crest factor	cf
Media parameters:	- Conductivity	
	- Density	

These parameters must be set correctly in the software. They can be found in the component documents or they can be imported into the software from the configuration files issued for the DASY4 components. In the direct measuring mode of the multimeter option, the parameters of the actual system setup are used. In the scan visualization and export modes, the parameters stored in the corresponding document files are used.

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics.

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Test Report

If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power. The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \cdot c f / d c p_i$$

With V_i = compensated signal of channel i (i = x, y, z)

U_i = input signal of channel i (i = x, y, z)

cf = crest factor of exciting field (DASY parameter)

dcp_i = diode compression point (DASY parameter)

From the compensated input signals the primary field data for each channel can be evaluated:

E-field probes: $E_i = (V_i / Norm_i \cdot ConvF)^{1/2}$

H-field probes: $H_i = (V_i)^{1/2} \cdot (a_{i0} + a_{i1} f + a_{i2} f^2) / f$

With V_i = compensated signal of channel i (i = x, y, z)

$Norm_i$ = sensor sensitivity of channel i (i = x, y, z)
[mV/(V/m)²] for E-field Probes

$ConvF$ = sensitivity enhancement in solution

a_{ij} = sensor sensitivity factors for H-field probes

f = carrier frequency [GHz]

E_i = electric field strength of channel i in V/m

H_i = magnetic field strength of channel i in A/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{tot} = (E_x^2 + E_y^2 + E_z^2)^{1/2}$$

The primary field data are used to calculate the derived field units.

$$SAR = (E_{tot}^2 \cdot \dots) / (\dots \cdot 1000)$$

with SAR = local specific absorption rate in mW/g

E_{tot} = total field strength in V/m

σ = conductivity in [mho/m] or [Siemens/m]

ρ = equivalent tissue density in g/cm³

Note that the density is normally set to 1 (or 1.06), to account for actual brain density rather than the density of the simulation liquid. The power flow density is calculated assuming the excitation field to be a free space field.

$$P_{pwe} = E_{tot}^2 / 3770 \quad \text{or} \quad P_{pwe} = H_{tot}^2 \cdot 37.7$$

with P_{pwe} = equivalent power density of a plane wave in mW/cm²

E_{tot} = total electric field strength in V/m

H_{tot} = total magnetic field strength in A/m

3.6. System check

The manufacturer calibrates the probes annually. Dielectric parameters of the tissue simulants were measured every day using the dielectric probe kit and the network analyzer. A system check measurement was made following the determination of the dielectric parameters of the simulant, using the dipole validation kit. A power level of 250 mW was supplied to the dipole antenna, which was placed under the flat section of the twin SAM phantom. The system check results (dielectric parameters and SAR values) are given in the table 6.

System check results have to be equal or near the values determined during dipole calibration with the relevant liquids and test system ($\pm 10\%$).

System check is performed regularly on all frequency bands where tests are performed with the DASY 4 system.

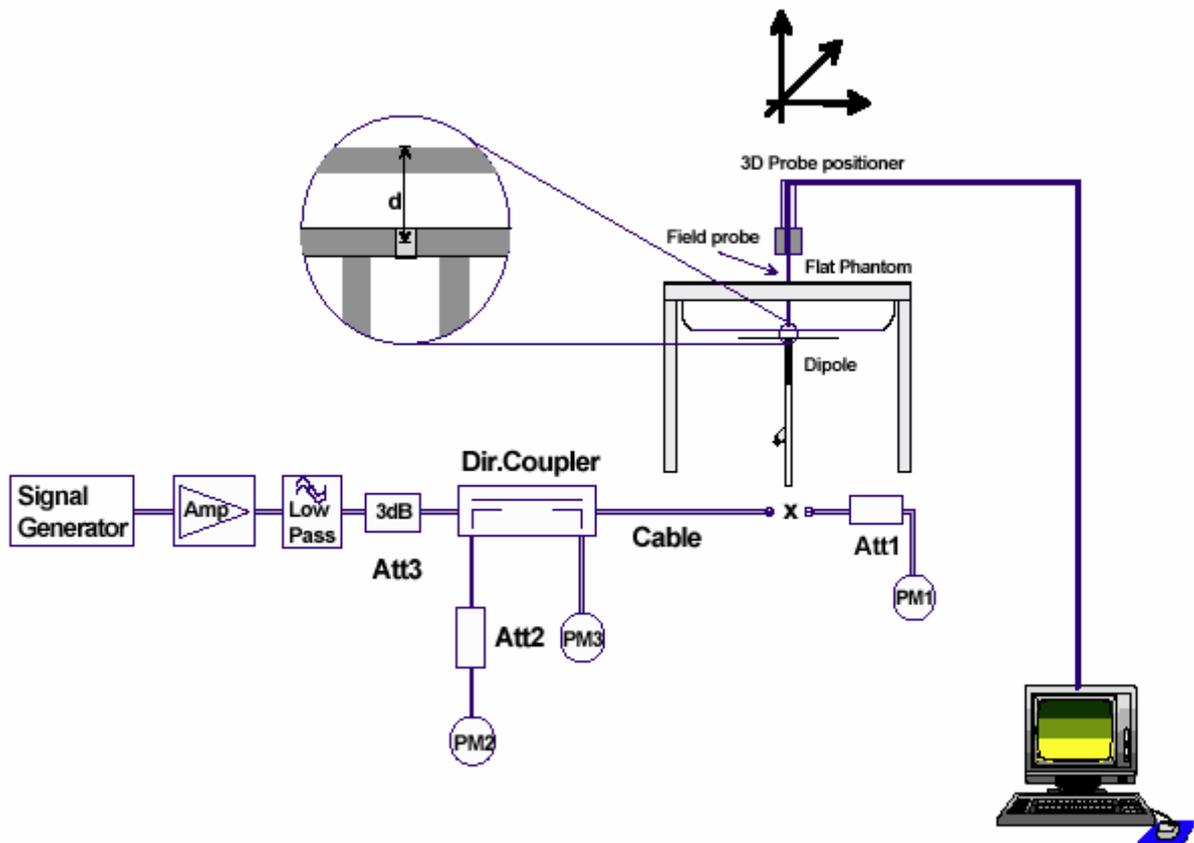


Figure 5. System Check Set-up

3.7. Equivalent Tissues

The liquid is consisted of water, sugar, salt, Glycol monobutyl, Preventol and Cellulose. The liquid has previously been proven to be suited for worst-case. The Table 2 shows the detail solution. It's satisfying the latest tissue dielectric parameters requirements proposed by OET 65.

Table 2: Composition of the Body Tissue Equivalent Matter

MIXTURE%	FREQUENCY(Body)835MHz
Water	52.5
Sugar	45
Salt	1.4
Preventol	0.1
Cellulose	1.0
Dielectric Parameters Target Value	f=835MHz $\epsilon=55.2$ $\sigma=0.97$

MIXTURE%	FREQUENCY (Body) 1900MHz
Water	69.91
Glycol monobutyl	29.96
Salt	0.13
Dielectric Parameters Target Value	f=1900MHz $\epsilon=53.3$ $\sigma=1.52$

4. Laboratory Environment

Table 3: The Ambient Conditions during Test

Temperature	Min. = 20°C, Max. = 25 °C
Relative humidity	Min. = 30%, Max. = 70%
Ground system resistance	< 0.5 Ω
Ambient noise is checked and found very low and in compliance with requirement of standards.	
Reflection of surrounding objects is minimized and in compliance with requirement of standards.	

5. Characteristics of the Test

5.1. Applicable Limit Regulations

IEEE Std C95.1, 1999: IEEE Standard for Safety Levels with Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3 kHz to 300 GHz.

5.2. Applicable Measurement Standards

SUPPLEMENT C Edition 01-01 to OET BULLETIN 65 Edition 97-01 June 2001 including DA 02-1438, published June 2002: Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields Additional Information for Evaluation Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions

KDB 447498 D02:2009-11-13

6. Conducted Output Power Measurement

6.1. Summary

The DUT is tested using an E5515C communications tester as controller unit to set test channels and maximum output power to the DUT, as well as for measuring the conducted power. Conducted output power was measured using an integrated RF connector and attached RF cable. This result contains conducted output power for the EUT.

6.2. Conducted Power Results

Table 4: Conducted Power Measurement Results

GSM850 + GPRS		Conducted Power(dBm)						
		Channel 128	Channel 190	Channel 251		Channel 128	Channel 190	Channel 251
1TXslot	Before	32.52	32.47	32.32	-9.03dB	23.49	23.44	23.29
	After	32.51	32.49	32.33	-9.03dB	23.48	23.46	23.30
2TXslots	Before	30.97	30.93	30.74	-6.02dB	24.95	24.91	24.72
	After	30.98	30.95	30.75	-6.02dB	24.96	24.93	24.73
GSM850 + EGPRS		Conducted Power(dBm)						
		Channel 128	Channel 190	Channel 251		Channel 128	Channel 190	Channel 251
1TXslot	Before	32.48	32.37	32.22	-9.03dB	23.45	23.34	23.19
	After	32.47	32.39	32.23	-9.03dB	23.44	23.36	23.20
2TXslots	Before	30.90	30.78	30.62	-6.02dB	24.88	24.76	24.60
	After	30.91	30.79	30.64	-6.02dB	24.89	24.77	24.62
3TXslots	Before	28.88	28.81	28.69	-4.26dB	24.62	24.55	24.43
	After	28.87	28.82	28.68	-4.26dB	24.61	24.56	24.42
4TXslots	Before	27.83	27.69	27.54	-3.01dB	24.82	24.68	24.53
	After	27.82	27.71	27.56	-3.01dB	24.81	24.70	24.55
GSM1900 + GPRS		Conducted Power(dBm)						
		Channel 512	Channel 661	Channel 810		Channel 512	Channel 661	Channel 810
1TXslot	Before	29.25	29.50	29.33	-9.03dB	20.22	20.47	20.30
	After	29.24	29.51	29.35	-9.03dB	20.21	20.48	20.32
2TXslots	Before	26.77	27.02	26.84	-6.02dB	20.75	21.00	20.82
	After	26.78	27.04	26.85	-6.02dB	20.76	21.02	20.83

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0732

Page 25 of 73

GSM1900 + EGPRS		Conducted Power(dBm)						
		Channel 512	Channel 661	Channel 810		Channel 512	Channel 661	Channel 810
1TXslot	Before	29.30	29.52	29.37	-9.03dB	20.27	20.49	20.34
	After	29.31	29.53	29.38	-9.03dB	20.28	20.50	20.35
2TXslots	Before	26.87	27.05	26.95	-6.02dB	20.85	21.03	20.93
	After	26.89	27.06	26.97	-6.02dB	20.87	21.04	20.95
3TXslots	Before	24.99	25.17	25.01	-4.26dB	20.73	20.91	20.75
	After	24.98	25.16	25.03	-4.26dB	20.72	20.90	20.77
4TXslots	Before	23.78	24.00	23.91	-3.01dB	20.77	20.99	20.90
	After	23.77	24.01	23.92	-3.01dB	20.76	21.00	20.91

Note:

1) Division Factors

To average the power, the division factor is as follows:

1 TX- slot = 1 transmit tome slot out of 8 time slots

=> conducted power divided by (8/1) => -9.03 dB

2 TX- slot = 2 transmit tome slots out of 8 time slots

=> conducted power divided by (8/2) => -6.02 dB

3TX- slot = 3 transmit tome slots out of 8 time slots

=> conducted power divided by (8/3) => -4.26 dB

4 TX- slot = 4 transmit tome slots out of 8 time slots

=> conducted power divided by (8/4) => -3.01 dB

2) Average power numbers

The maximum power numbers are marks in bold.

3) For SAR testing the EUT was set to multislot class based on the maximum averaged conducted power.

7. Test Results

7.1. Dielectric Performance

Table 5: Dielectric Performance of Body Tissue Simulating Liquid

Frequency	Description	Dielectric Parameters		Temp °C
		ϵ_r	σ (s/m)	
835MHz (body)	Target value ±5% window	55.20 52.44 — 57.96	0.97 0.92 — 1.02	/
	Measurement value 2010-5-11	54.00	0.99	21.5
1900MHz (body)	Target value ±5% window	53.30 50.64 — 55.97	1.52 1.44 — 1.60	/
	Measurement value 2010-5-11	52.29	1.56	21.7

7.2. System Check

Table 6: System Check for Body Tissue Simulation Liquid

Frequency	Description	SAR(W/kg)		Dielectric Parameters		Temp °C
		10g	1g	ϵ_r	σ (s/m)	
835MHz	Recommended result ±10% window	1.68 1.51 - 1.85	2.56 2.30 - 2.82	53	0.99	/
	Measurement value 2010-5-11	1.55	2.37	54.00	0.99	21.9
1900 MHz	Recommended result ±10% window	5.52 4.97—6.07	10.50 9.45 — 11.55	54	1.55	/
	Measurement value 2010-5-11	5.13	10.00	52.29	1.56	21.7

Note: 1. The graph results see ANNEX B.

2. Target Values used derive from the calibration certificate and 250 mW is used as feeding power to the Calibrated dipole.

TA Technology (Shanghai) Co., Ltd.

Test Report

7.3. Summary of Measurement Results

7.3.1. GSM 850(GPRS/EGPRS)

Table 7: SAR Values [GSM850 (GPRS/EGPRS), initial model test data]

Limit of SAR (W/kg)			10 g Average	1g Average	Power Drift(dB)	Graph Results
			2.0	1.6	± 0.21	
Test Case Of Body			Measurement Result (W/kg)		Power Drift(dB)	
Different Test Position	Different Timeslots	Channel	10 g Average	1 g Average		
IBM T61						
Test Position 1	2 timeslots	High	0.591	0.902	0.090	/
		Middle	0.563	0.859	-0.041	/
		Low	0.515	0.786	0.182	/
Test Position 2	2 timeslots	Middle	0.454	0.743	-0.171	/
Test Position 3	2 timeslots	Middle	0.151(max.cube)	0.246(max.cube)	-0.122	/
Test Position 4	2 timeslots	Middle	0.407	0.634	-0.164	/
Worst case position of GPRS with EGPRS						
Test Position 1	2 timeslots	High	0.585	0.894	0.052	/

Note: 1. The value with blue color is the maximum SAR Value of each test band.

2. The SAR test shall be performed at the high, middle and low frequency channels of each operating mode. If the SAR measured at mid-band channel for each test configuration is at least 3.0 dB (< 0.8W/kg) lower than the SAR limit, testing at the high and low channels is optional.

3. Upper and lower frequencies were measured at the worst case.

4. The (max.cube) labeling indicates that during the grid scanning an additional peak was found which was within 2.0dB of the highest peak. The value of the highest cube is given in the table above;

5. The SAR Values are for initial model in the table 7.

Table 8: SAR Values (GSM850, initial model test data, enhanced energy coupling at increased separation distances)

Different Test Position	Distance of EUT to Phantom	Channel	Measurement Result (W/kg)	50% of initial position SAR (W/kg)	125% of initial position SAR (W/kg)
Test Position 1	initial position	High	1.163	0.582	1.454
	5mm		0.816		
	10mm		0.517		

Note: 1. The probe tip location is fixed at the distance of 2mm from the phantom surface.

2. when the device position with the highest point SAR is > 25% of that measured at the initial position, a complete 1-g SAR evaluation is required for this configuration.

3. A single point SAR is measured for each of these device positions until the SAR is less than 50% of that measured at the initial position.

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA2010-0732

Page 28 of 73

Table 9: SAR Values [GSM850 (GPRS/EGPRS), variant model test data]

Limit of SAR (W/kg)			10 g Average	1g Average	Power Drift(dB)	Graph Results
			2.0	1.6	± 0.21	
Test Case Of Body			Measurement Result (W/kg)		Power Drift(dB)	
Different Test Position	Different Timeslots	Channel	10 g Average	1 g Average		
Worst case position of initial model with variant model						
Test Position 1	2 timeslots	High	0.696	1.070	-0.086	Figure 8

- Note: 1. The SAR Values are for variant model in the table 9.
2. This test is only performed with worst case test position of the initial test.

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0732

Page 29 of 73

7.3.2. GSM 1900(GPRS/EGPRS)

Table 10: SAR Values [GSM1900 (GPRS/EGPRS), initial model test data]

Limit of SAR (W/kg)			10 g Average	1g Average	Power Drift(dB)	Graph Results
			2.0	1.6	± 0.21	
Test Case Of Body			Measurement Result (W/kg)		Power Drift(dB)	
Different Test Position	Different Timeslots	Channel	10 g Average	1 g Average		
IBM T61						
Test Position 1	2 timeslots	High	0.418	0.801	-0.038	/
		Middle	0.530	1.100	-0.041	/
		Low	0.528	0.927	-0.008	/
Test Position 2	2 timeslots	High	0.425	0.952	0.044	/
		Middle	0.357	0.856	-0.093	/
		Low	0.319(max.cube)	0.628(max.cube)	0.000	/
Test Position 3	2 timeslots	Middle	0.150	0.292	0.016	/
Test Position 4	2 timeslots	High	0.459	1.090	0.078	/
		Middle	0.512	1.120	-0.020	/
		Low	0.398	0.803	0.008	/
Worst case position of GPRS with EGPRS						
Test Position 4	2 timeslots	Middle	0.511	1.130	0.066	/

Note: 1. The value with blue color is the maximum SAR Value of each test band.

2. The SAR test shall be performed at the high, middle and low frequency channels of each operating mode. If the SAR measured at mid-band channel for each test configuration is at least 3.0 dB (< 0.8W/kg) lower than the SAR limit, testing at the high and low channels is optional.

3. Upper and lower frequencies were measured at the worst case.

4. The (max.cube) labeling indicates that during the grid scanning an additional peak was found which was within 2.0dB of the highest peak. The value of the highest cube is given in the table above;

Table 11: SAR Values (GSM1900, initial model test data, enhanced energy coupling at increased separation distances)

Different Test Position	Distance of EUT to Phantom	Channel	Measurement Result (W/kg)	50% of initial position SAR (W/kg)	125% of initial position SAR (W/kg)
Test Position 4	initial position	Middle	1.562	0.781	1.953
	5mm		0.494		

Note: 1. The probe tip location is fixed at the distance of 2mm from the phantom surface.

2. when the device position with the highest point SAR is > 25% of that measured at the initial position, a complete 1-g SAR evaluation is required for this configuration.

3. A single point SAR is measured for each of these device positions until the SAR is less than 50% of that measured at the initial position.

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA2010-0732

Page 30 of 73

Table 12: SAR Values [GSM1900 (GPRS/EGPRS), variant model test data]

Limit of SAR (W/kg)			10 g Average	1g Average	Power Drift(dB)	Graph Results
			2.0	1.6	± 0.21	
Test Case Of Body			Measurement Result (W/kg)		Power Drift(dB)	
Different Test Position	Different Timeslots	Channel	10 g Average	1 g Average		
Worst case position of initial model with variant model						
Test Position 4	2 timeslots	Middle	0.470	0.998	0.069	Figure 9

- Note: 1. The SAR Values are for variant model in the table 12.
2. This test is only performed with worst case test position of the initial test.

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA2010-0732

Page 31 of 73

8. Measurement Uncertainty

No.	source	Type	Uncertainty Value (%)	Probability Distribution	k	c _i	Standard uncertainty u _i (%)	Degree of freedom V _{eff} or v _i
1	System repetivity	A	0.5	N	1	1	0.5	9
Measurement system								
2	probe calibration	B	5.9	N	1	1	5.9	∞
3	axial isotropy of the probe	B	4.7	R	$\sqrt{3}$	$\sqrt{0.5}$	1.9	∞
4	Hemispherical isotropy of the probe	B	9.4	R	$\sqrt{3}$	$\sqrt{0.5}$	3.9	∞
6	boundary effect	B	1.9	R	$\sqrt{3}$	1	1.1	∞
7	probe linearity	B	4.7	R	$\sqrt{3}$	1	2.7	∞
8	System detection limits	B	1.0	R	$\sqrt{3}$	1	0.6	∞
9	readout Electronics	B	1.0	N	1	1	1.0	∞
10	response time	B	0	R	$\sqrt{3}$	1	0	∞
11	integration time	B	4.32	R	$\sqrt{3}$	1	2.5	∞
12	noise	B	0	R	$\sqrt{3}$	1	0	∞
13	RF Ambient Conditions	B	3	R	$\sqrt{3}$	1	1.73	∞
14	Probe Positioner Mechanical Tolerance	B	0.4	R	$\sqrt{3}$	1	0.2	∞
15	Probe Positioning with respect to Phantom Shell	B	2.9	R	$\sqrt{3}$	1	1.7	∞
16	Extrapolation, interpolation and Integration Algorithms for Max. SAR Evaluation	B	3.9	R	$\sqrt{3}$	1	2.3	∞
Test sample Related								
17	-Test Sample Positioning	A	2.9	N	1	1	2.9	5
18	-Device Holder Uncertainty	A	4.1	N	1	1	4.1	5
19	-Output Power Variation - SAR drift measurement	B	5.0	R	$\sqrt{3}$	1	2.9	∞
Physical parameter								

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA2010-0732

Page 32 of 73

20	-phantom	B	4.0	R	$\sqrt{3}$	1	2.3	∞
21	-liquid conductivity (deviation from target)	B	5.0	R	$\sqrt{3}$	0.64	1.8	∞
22	-liquid conductivity (measurement uncertainty)	B	5.0	N	1	0.64	3.2	∞
23	-liquid permittivity (deviation from target)	B	5.0	R	$\sqrt{3}$	0.6	1.7	∞
24	-liquid permittivity (measurement uncertainty)	B	5.0	N	1	0.6	3.0	∞
Combined standard uncertainty		$u_c = \sqrt{\sum_{i=1}^{21} c_i^2 u_i^2}$				12.0		
Expanded uncertainty (confidence interval of 95 %)		$u_e = 2u_c$		N	k=2	24.0		

9. Main Test Instruments

Table 13: List of Main Instruments

No.	Name	Type	Serial Number	Calibration Date	Valid Period
01	Network analyzer	Agilent 8753E	US37390326	September 13, 2009	One year
02	Dielectric Probe Kit	Agilent 85070E	US44020115	No Calibration Requested	
03	Power meter	Agilent E4417A	GB41291714	March 13, 2010	One year
04	Power sensor	Agilent 8481H	MY41091316	March 26, 2010	One year
05	Signal Generator	HP 8341B	2730A00804	September 13, 2009	One year
06	Amplifier	IXA-020	0401	No Calibration Requested	
07	Validation Kit 835MHz	D835V2	4d082	July 13, 2009	One year
08	Validation Kit 1900MHz	D1900V2	5d018	June 26, 2009	One year
09	BTS	E5515C	MY48360988	December 4, 2009	One year
10	E-field Probe	EX3DV4	3677	September 23, 2009	One year
11	DAE	DAE4	905	June 24, 2009	One year

END OF REPORT BODY

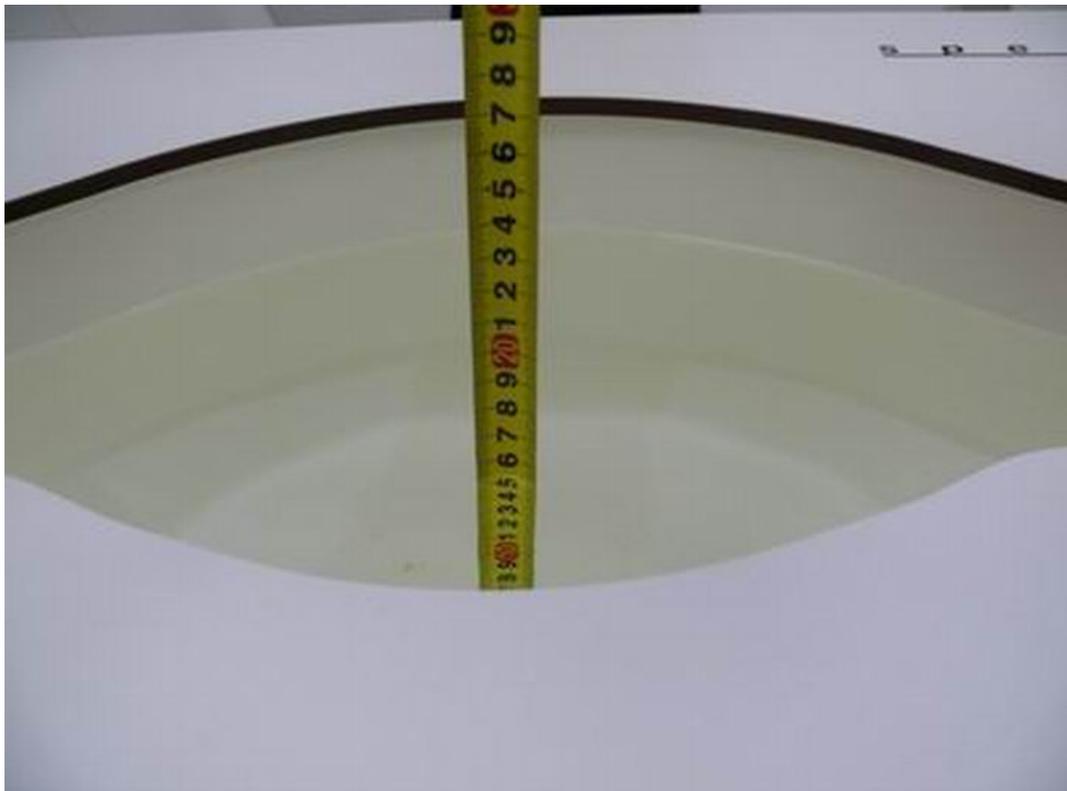
ANNEX A: Test Layout



Picture 2: Specific Absorption Rate Test Layout



**Picture 3: Liquid depth in the Flat Phantom (835 MHz)
(15.2cm deep)**



**Picture 4: Liquid depth in the Flat Phantom (1900 MHz)
(15.2cm deep)**

ANNEX B: System Check Results

System Performance Check at 835 MHz

DUT: Dipole 835 MHz; Type: D835V2; Serial: D835V2 - SN:4d082

Date/Time: 5/11/2010 1:01:32 PM

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium parameters used: $f = 835$ MHz; $\sigma = 0.99$ mho/m; $\epsilon_r = 54.00$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: Flat Section

DASY4 Configuration:

Probe: EX3DV4 – SN3677; ConvF(9.11, 9.11, 9.11); Calibrated: 9/23/2009

Electronics: DAE4 Sn905; Calibrated: 6/24/2009

Phantom: SAM 12; Type: SAM V4.0; Serial: TP-1246

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

d=15mm, Pin=250mW/Area Scan (101x121x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 2.91 mW/g

d=15mm, Pin=250mW/Zoom Scan (7x7x7) /Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 55.6 V/m; Power Drift = -0.014 dB

Peak SAR (extrapolated) = 3.57 W/kg

SAR(1 g) = 2.37 mW/g; SAR(10 g) = 1.55 mW/g

Maximum value of SAR (measured) = 2.92 mW/g

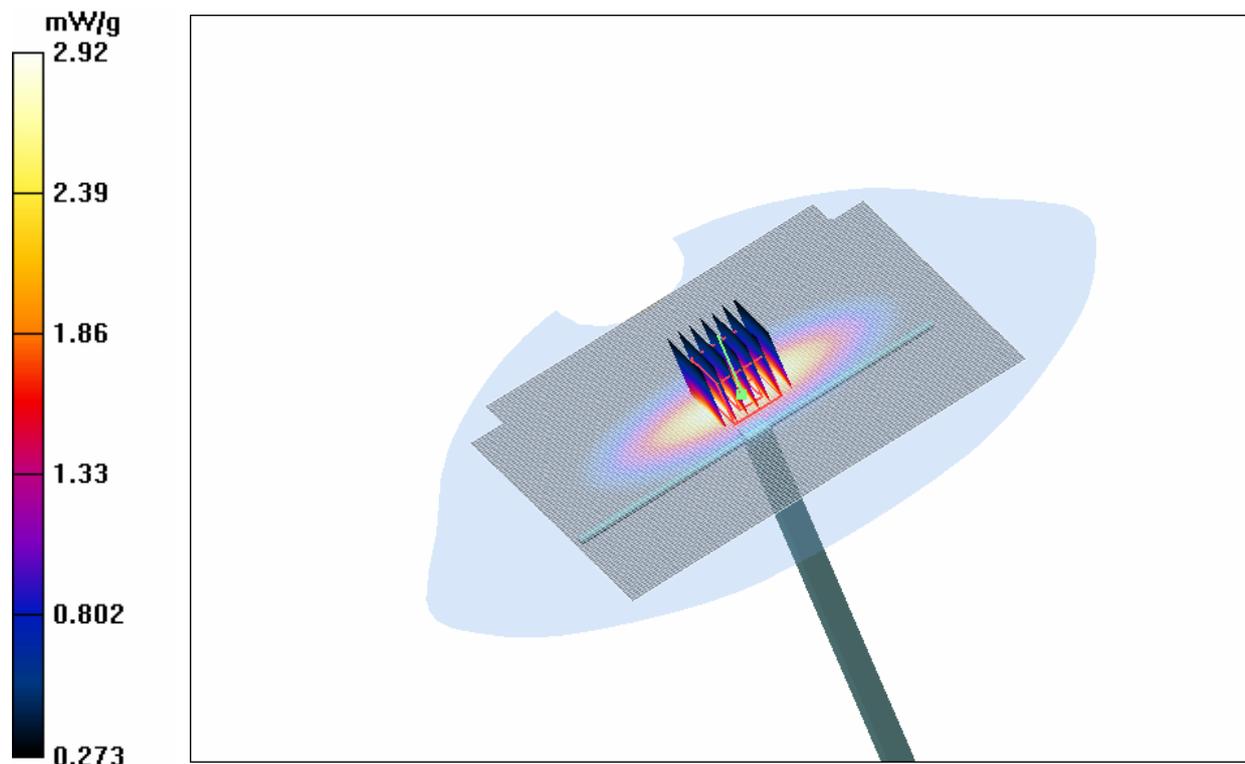


Figure 6 System Performance Check 835MHz 250mW

System Performance Check at 1900 MHz

DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN:5d018

Date/Time: 5/11/2010 10:06:18 AM

Communication System: CW; Frequency: 1900 MHz; Duty Cycle: 1:1

Medium parameters used: $f = 1900$ MHz; $\sigma = 1.56$ mho/m; $\epsilon_r = 52.29$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: Flat Section

DASY4 Configuration:

Probe: EX3DV4 – SN3677; ConvF(7.62, 7.62, 7.62); Calibrated: 9/23/2009

Electronics: DAE4 Sn905; Calibrated: 6/24/2009

Phantom: SAM000 T01 ; Type: SAM V4.0; Serial: TP-1246

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

d=10mm, Pin=250mW/Area Scan (101x121x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 11.8 mW/g

d=10mm, Pin=250mW/Zoom Scan (7x7x7) /Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 86.1 V/m; Power Drift = -0.017 dB

Peak SAR (extrapolated) = 18.8 W/kg

SAR(1 g) = 10.00 mW/g; SAR(10 g) = 5.13 mW/g

Maximum value of SAR (measured) = 11.3 mW/g

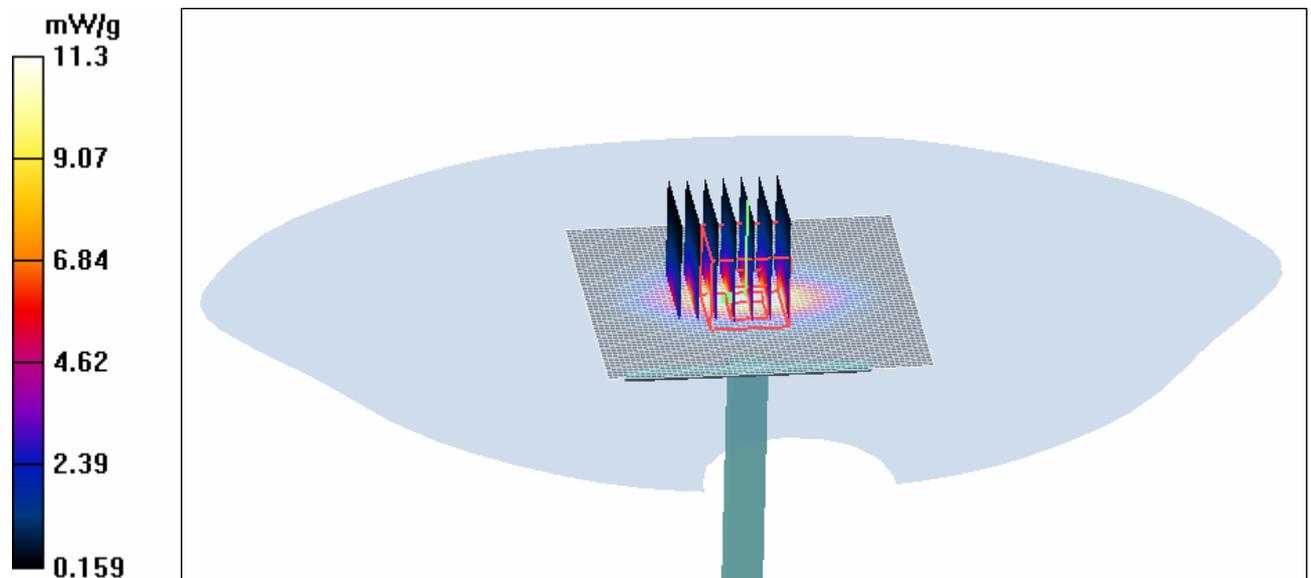


Figure 7 System Performance Check 1900MHz 250mW

ANNEX C: Graph Results

GSM 850 GPRS (2 timeslots in uplink) with IBM T61 Test Position 1 High Frequency

Date/Time: 5/11/2010 3:10:04 PM

Communication System: GSM850 + GPRS(2Up); Frequency: 848.8 MHz; Duty Cycle: 1:4.15

Medium parameters used: $f = 849$ MHz; $\sigma = 1.01$ mho/m; $\epsilon_r = 53.8$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

DASY4 Configuration:

Probe: EX3DV4 – SN3677; ConvF(9.11, 9.11, 9.11); Calibrated: 9/23/2009

Electronics: DAE4 Sn905; Calibrated: 6/24/2009

Phantom: SAM1; Type: SAM;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

Test Position 1 High/Area Scan (61x121x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 1.2 mW/g

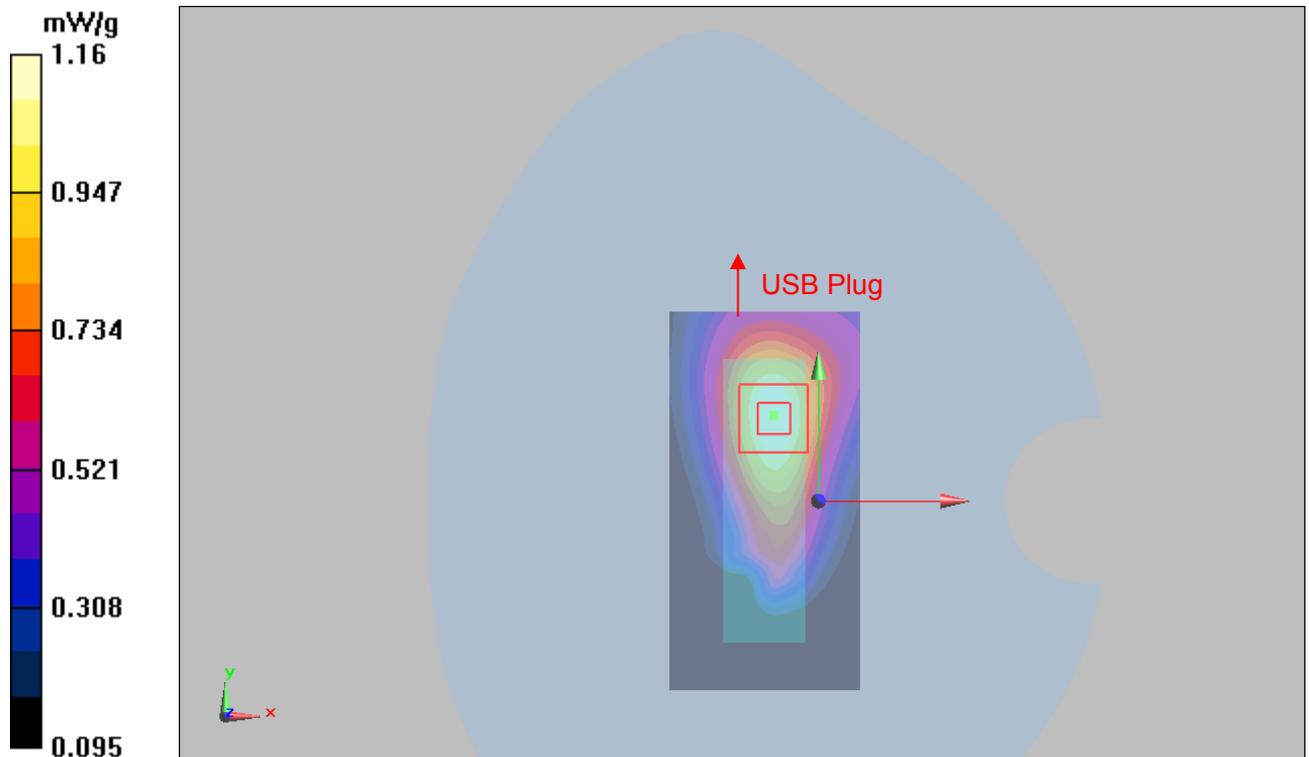
Test Position 1 High/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 30.8 V/m; Power Drift = -0.086 dB

Peak SAR (extrapolated) = 1.6 W/kg

SAR(1 g) = 1.07 mW/g; SAR(10 g) = 0.696 mW/g

Maximum value of SAR (measured) = 1.16 mW/g



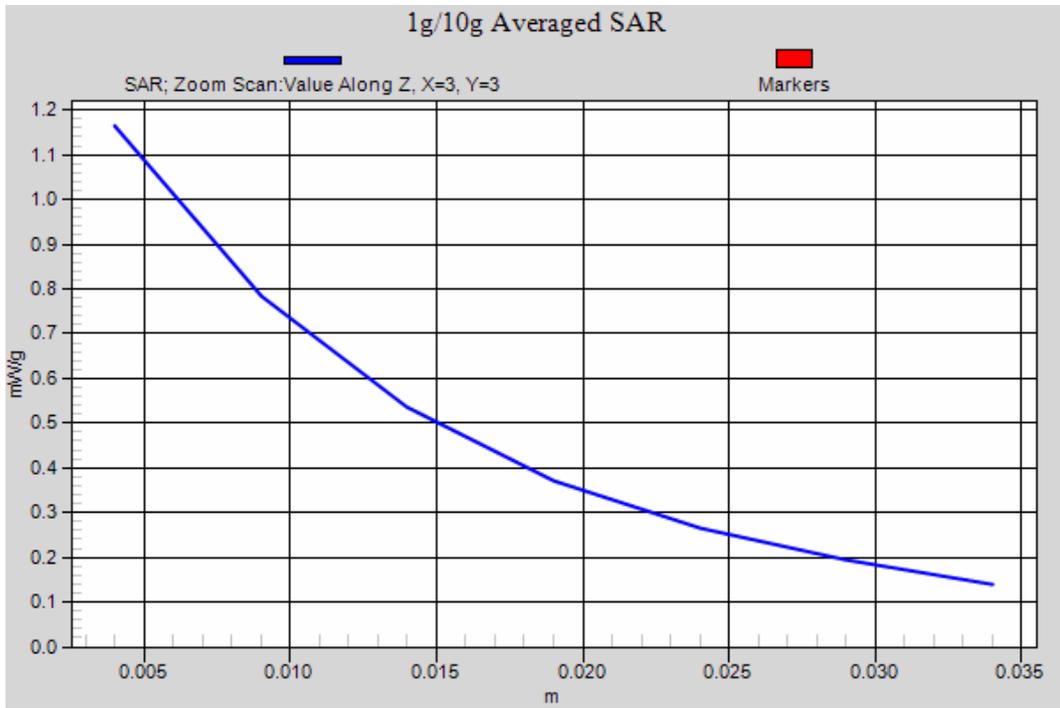


Figure 8 GSM 850 GPRS (2 timeslots in uplink) with IBM T61 Test Position 1 Channel 251

GSM 1900 EGPRS (2 timeslots in uplink) with IBM T61 Test Position 4 Middle Frequency

Date/Time: 5/11/2010 4:17:07 PM

Communication System: PCS 1900+EGPRS(2Up); Frequency: 1880 MHz; Duty Cycle: 1:4.15

Medium parameters used: $f = 1880$ MHz; $\sigma = 1.54$ mho/m; $\epsilon_r = 52.3$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

DASY4 Configuration:

Probe: EX3DV4 – SN3677; ConvF(7.62, 7.62, 7.62); Calibrated: 9/23/2009

Electronics: DAE4 Sn905; Calibrated: 6/24/2009

Phantom: SAM2; Type: SAM;

Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

Test Position 4 Middle/Area Scan (61x121x1): Measurement grid: dx=10mm, dy=10mm

Maximum value of SAR (interpolated) = 1.15 mW/g

Test Position 4 Middle/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 18.3 V/m; Power Drift = 0.069 dB

Peak SAR (extrapolated) = 2.39 W/kg

SAR(1 g) = 0.998 mW/g; SAR(10 g) = 0.470 mW/g

Maximum value of SAR (measured) = 1.12 mW/g

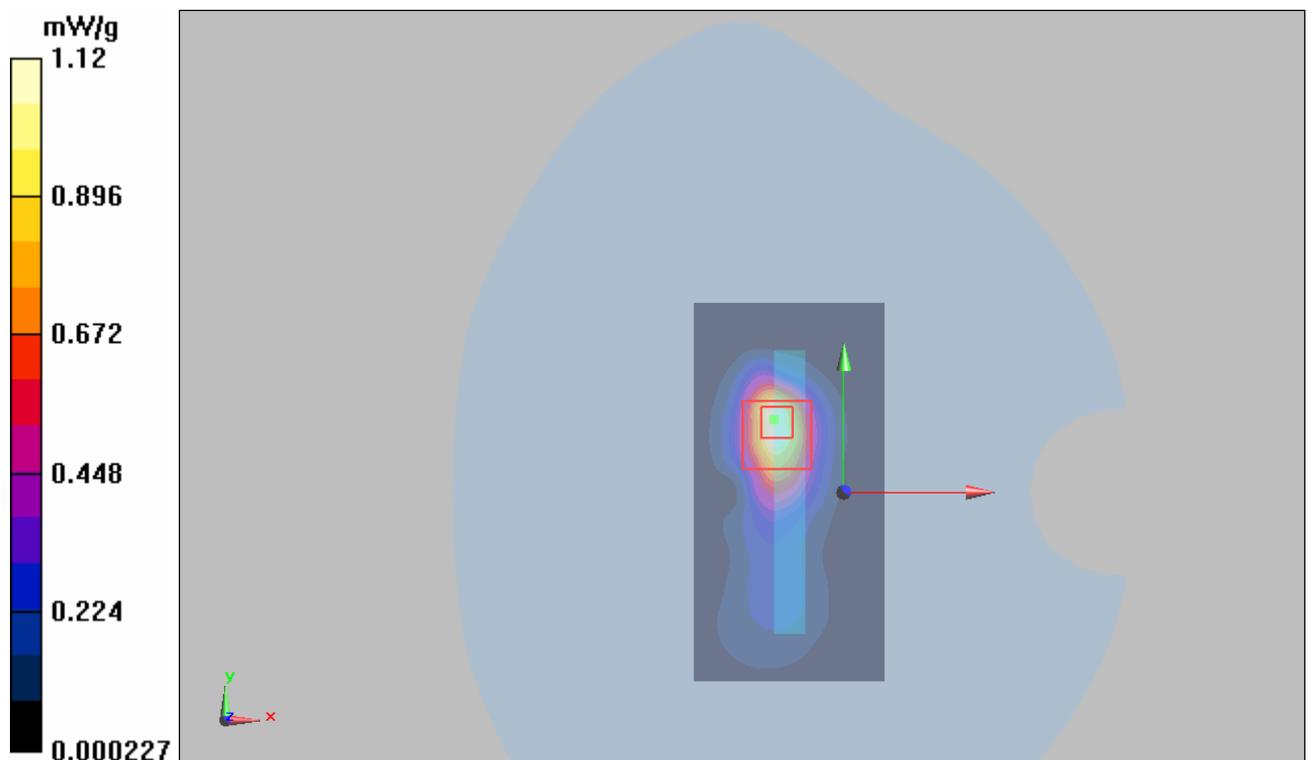


Figure 9 GSM 1900 EGPRS (2 timeslots in uplink) with IBM T61 Test Position 4 Channel 661

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0732

Page 40 of 73

ANNEX D: Probe Calibration Certificate

**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **TA (Auden)**

Certificate No: **EX3-3677_Sep09**

CALIBRATION CERTIFICATE																																																			
Object	EX3DV4 - SN:3677																																																		
Calibration procedure(s)	QA CAL-01.v6, QA CAL-12.v5, QA CAL-23.v3 and QA CAL-25.v2 - Calibration procedure for dosimetric E-field probes																																																		
Calibration date:	September 23, 2009																																																		
Condition of the calibrated item	In Tolerance																																																		
<p>This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.</p> <p>All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.</p> <p>Calibration Equipment used (M&TE critical for calibration)</p> <table border="1" style="width: 100%; border-collapse: collapse;"> <thead> <tr> <th>Primary Standards</th> <th>ID #</th> <th>Cal Date (Certificate No.)</th> <th>Scheduled Calibration</th> </tr> </thead> <tbody> <tr> <td>Power meter E4419B</td> <td>GB41293874</td> <td>1-Apr-09 (No. 217-01030)</td> <td>Apr-10</td> </tr> <tr> <td>Power sensor E4412A</td> <td>MY41495277</td> <td>1-Apr-09 (No. 217-01030)</td> <td>Apr-10</td> </tr> <tr> <td>Power sensor E4412A</td> <td>MY41498087</td> <td>1-Apr-09 (No. 217-01030)</td> <td>Apr-10</td> </tr> <tr> <td>Reference 3 dB Attenuator</td> <td>SN: S5054 (3c)</td> <td>31-Mar-09 (No. 217-01026)</td> <td>Mar-10</td> </tr> <tr> <td>Reference 20 dB Attenuator</td> <td>SN: S5086 (20b)</td> <td>31-Mar-09 (No. 217-01028)</td> <td>Mar-10</td> </tr> <tr> <td>Reference 30 dB Attenuator</td> <td>SN: S5129 (30b)</td> <td>31-Mar-09 (No. 217-01027)</td> <td>Mar-10</td> </tr> <tr> <td>Reference Probe ES3DV2</td> <td>SN: 3013</td> <td>2-Jan-09 (No. ES3-3013_Jan09)</td> <td>Jan-10</td> </tr> <tr> <td>DAE4</td> <td>SN: 660</td> <td>9-Sep-08 (No. DAE4-660_Sep08)</td> <td>Sep-09</td> </tr> </tbody> </table> <table border="1" style="width: 100%; border-collapse: collapse;"> <thead> <tr> <th>Secondary Standards</th> <th>ID #</th> <th>Check Date (in house)</th> <th>Scheduled Check</th> </tr> </thead> <tbody> <tr> <td>RF generator HP 8648C</td> <td>US3642U01700</td> <td>4-Aug-99 (in house check Oct-07)</td> <td>In house check: Oct-09</td> </tr> <tr> <td>Network Analyzer HP 8753E</td> <td>US37390585</td> <td>18-Oct-01 (in house check Oct-08)</td> <td>In house check: Oct-09</td> </tr> </tbody> </table>				Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration	Power meter E4419B	GB41293874	1-Apr-09 (No. 217-01030)	Apr-10	Power sensor E4412A	MY41495277	1-Apr-09 (No. 217-01030)	Apr-10	Power sensor E4412A	MY41498087	1-Apr-09 (No. 217-01030)	Apr-10	Reference 3 dB Attenuator	SN: S5054 (3c)	31-Mar-09 (No. 217-01026)	Mar-10	Reference 20 dB Attenuator	SN: S5086 (20b)	31-Mar-09 (No. 217-01028)	Mar-10	Reference 30 dB Attenuator	SN: S5129 (30b)	31-Mar-09 (No. 217-01027)	Mar-10	Reference Probe ES3DV2	SN: 3013	2-Jan-09 (No. ES3-3013_Jan09)	Jan-10	DAE4	SN: 660	9-Sep-08 (No. DAE4-660_Sep08)	Sep-09	Secondary Standards	ID #	Check Date (in house)	Scheduled Check	RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Oct-07)	In house check: Oct-09	Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-08)	In house check: Oct-09
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Calibrated by:	Name Claudio Leubler	Function Laboratory Technician	Signature 																																																
Approved by:	Name Katja Pokovic	Function Technical Manager	Signature 																																																
Issued: September 23, 2009																																																			
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TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RZA2010-0732

Page 41 of 73

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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Glossary:

TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}**: Assessed for E-field polarization $\vartheta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not effect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)_{x,y,z} = NORM_{x,y,z} * frequency_response** (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- ConvF and Boundary Effect Parameters**: Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy)**: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

EX3DV4 SN:3677

September 23, 2009

Probe EX3DV4

SN:3677

Manufactured:	September 9, 2008
Last calibrated:	November 7, 2008
Recalibrated:	September 23, 2009

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0732

Page 43of 73

EX3DV4 SN:3677

September 23, 2009

DASY - Parameters of Probe: EX3DV4 SN:3677

Sensitivity in Free Space^A

Diode Compression^B

NormX	0.42 ± 10.1%	$\mu\text{V}/(\text{V}/\text{m})^2$	DCP X	91 mV
NormY	0.47 ± 10.1%	$\mu\text{V}/(\text{V}/\text{m})^2$	DCP Y	92 mV
NormZ	0.40 ± 10.1%	$\mu\text{V}/(\text{V}/\text{m})^2$	DCP Z	93 mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 8.

Boundary Effect

TSL 900 MHz Typical SAR gradient: 5 % per mm

Sensor Center to Phantom Surface Distance	2.0 mm	3.0 mm
SAR _{be} [%] Without Correction Algorithm	8.2	4.4
SAR _{be} [%] With Correction Algorithm	0.8	0.5

TSL 1750 MHz Typical SAR gradient: 10 % per mm

Sensor Center to Phantom Surface Distance	2.0 mm	3.0 mm
SAR _{be} [%] Without Correction Algorithm	7.5	3.9
SAR _{be} [%] With Correction Algorithm	0.8	0.4

Sensor Offset

Probe Tip to Sensor Center **1.0 mm**

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of NormX,Y,Z do not affect the E²-field uncertainty inside TSL (see Page 8).

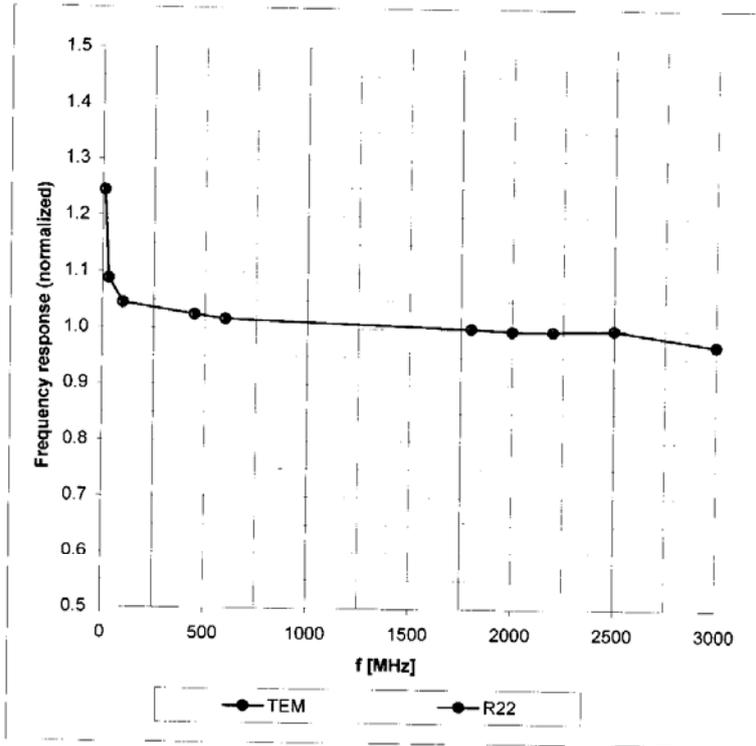
^B Numerical linearization parameter: uncertainty not required.

EX3DV4 SN:3677

September 23, 2009

Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide: R22)

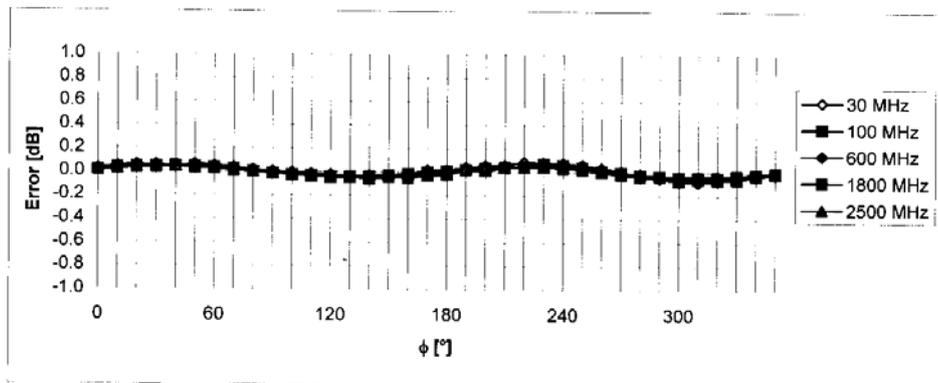
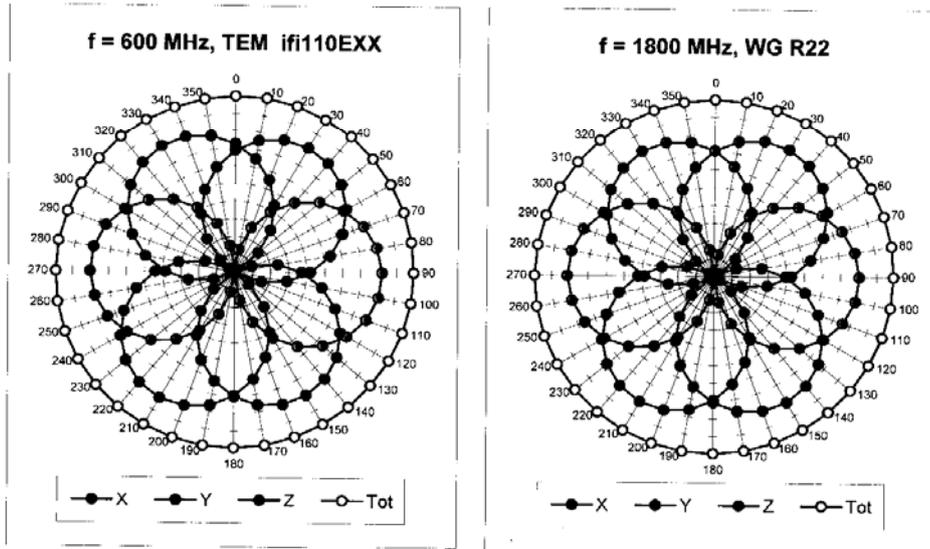


Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

EX3DV4 SN:3677

September 23, 2009

Receiving Pattern (ϕ), $\vartheta = 0^\circ$

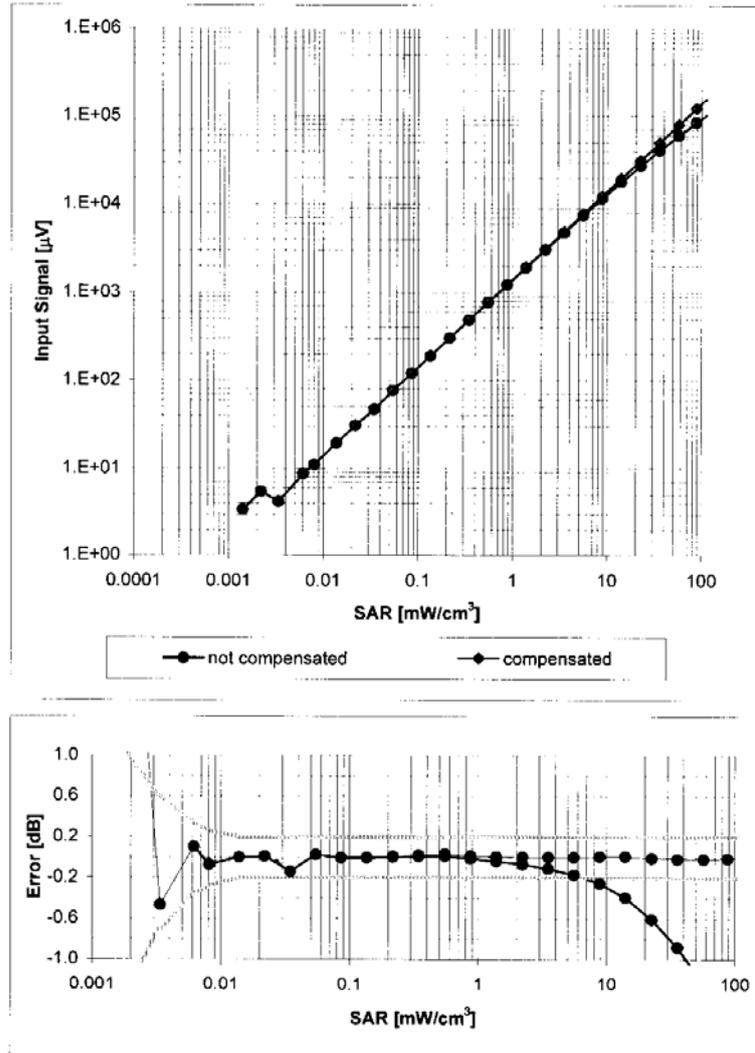


Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ (k=2)

EX3DV4 SN:3677

September 23, 2009

Dynamic Range $f(\text{SAR}_{\text{head}})$
(Waveguide R22, $f = 1800 \text{ MHz}$)

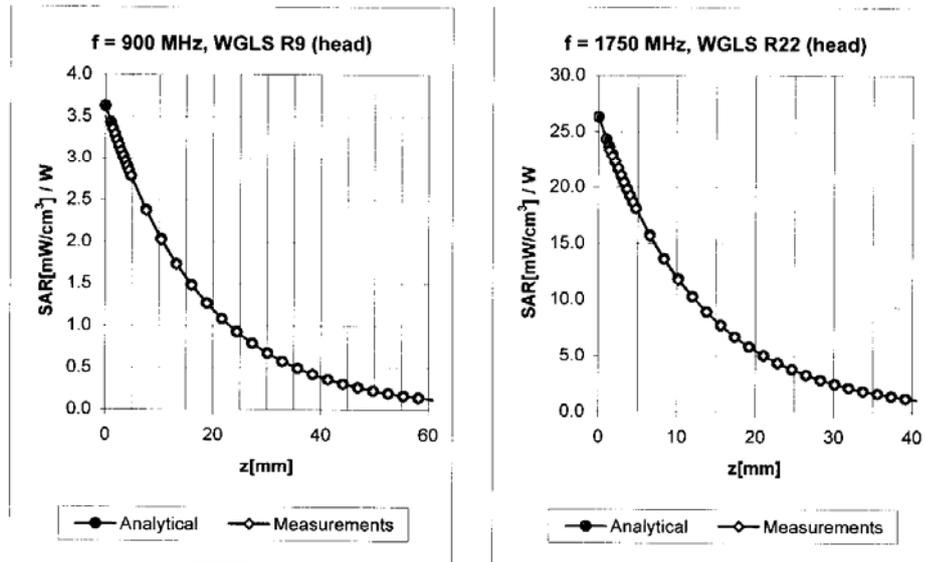


Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)

EX3DV4 SN:3677

September 23, 2009

Conversion Factor Assessment



f [MHz]	Validity [MHz] ^c	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
835	± 50 / ± 100	Head	41.5 ± 5%	0.90 ± 5%	0.68	0.64	9.20 ± 11.0% (k=2)
900	± 50 / ± 100	Head	41.5 ± 5%	0.97 ± 5%	0.71	0.62	8.91 ± 11.0% (k=2)
1750	± 50 / ± 100	Head	40.1 ± 5%	1.37 ± 5%	0.68	0.62	8.04 ± 11.0% (k=2)
1950	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.70	0.60	7.53 ± 11.0% (k=2)
450	± 50 / ± 100	Body	56.7 ± 5%	0.94 ± 5%	0.32	0.49	10.43 ± 13.3% (k=2)
835	± 50 / ± 100	Body	55.2 ± 5%	0.97 ± 5%	0.54	0.73	9.11 ± 11.0% (k=2)
900	± 50 / ± 100	Body	55.0 ± 5%	1.05 ± 5%	0.63	0.71	8.89 ± 11.0% (k=2)
1750	± 50 / ± 100	Body	53.4 ± 5%	1.49 ± 5%	0.55	0.74	7.70 ± 11.0% (k=2)
1950	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.30	1.01	7.62 ± 11.0% (k=2)
2450	± 50 / ± 100	Body	52.7 ± 5%	1.95 ± 5%	0.56	0.68	7.28 ± 11.0% (k=2)

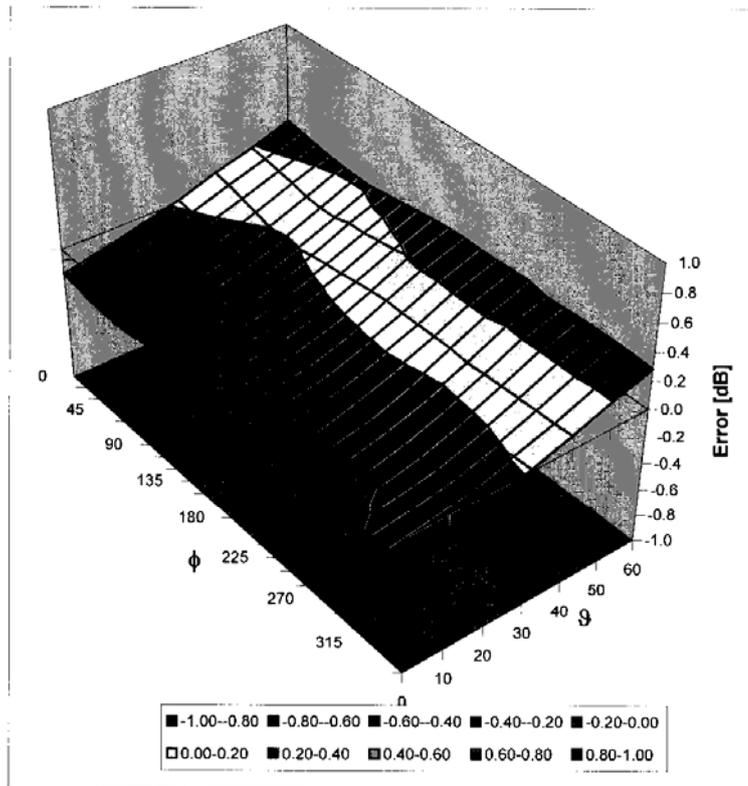
^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

EX3DV4 SN:3677

September 23, 2009

Deviation from Isotropy in HSL

Error (ϕ , ϑ), $f = 900$ MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ ($k=2$)

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0732

Page 49 of 73

ANNEX E: D835V2 Dipole Calibration Certificate

**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



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The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **ATL (Auden)**

Certificate No: **D835V2-4d082_Jul09**

CALIBRATION CERTIFICATE

Object: **D835V2 - SN: 4d082**

Calibration procedure(s): **QA CAL-05.v7
Calibration procedure for dipole validation kits**

Calibration date: **July 13, 2009**

Condition of the calibrated item: **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	08-Oct-08 (No. 217-00898)	Oct-09
Power sensor HP 8481A	US37292783	08-Oct-08 (No. 217-00898)	Oct-09
Reference 20 dB Attenuator	SN: 5086 (20g)	31-Mar-09 (No. 217-01025)	Mar-10
Type-N mismatch combination	SN: 5047.2 / 06327	31-Mar-09 (No. 217-01029)	Mar-10
Reference Probe ES3DV2	SN: 3025	30-Apr-09 (No. ES3-3025_Apr09)	Apr-10
DAE4	SN: 601	07-Mar-09 (No. DAE4-601_Mar09)	Mar-10
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (in house check Oct-07)	In house check: Oct-09
RF generator R&S SMT-06	100005	4-Aug-99 (in house check Oct-07)	In house check: Oct-09
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (in house check Oct-08)	In house check: Oct-09

	Name	Function	Signature
Calibrated by:	Jeton Kastrati	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	

Issued: July 13, 2009

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Test Report

Report No. RZA2010-0732

Page 50 of 73

Calibration Laboratory of
Schmid & Partner
Engineering AG
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S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Glossary:

TSL tissue simulating liquid
ConvF sensitivity in TSL / NORM x,y,z
N/A not applicable or not measured

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

- DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions:** Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL:** The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss:** These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay:** One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured:** SAR measured at the stated antenna input power.
- SAR normalized:** SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters:** The measured TSL parameters are used to calculate the nominal SAR result.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V5.0
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V4.9	
Distance Dipole Center - TSL	15 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	835 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	41.5	0.90 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	40.4 ± 6 %	0.89 mho/m ± 6 %
Head TSL temperature during test	(22.2 ± 0.2) °C	---	---

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	2.42 mW / g
SAR normalized	normalized to 1W	9.68 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	9.71 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	1.58 mW / g
SAR normalized	normalized to 1W	6.32 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	6.34 mW / g ± 16.5 % (k=2)

¹ Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

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Body TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	55.2	0.97 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	53.0 ± 6 %	0.99 mho/m ± 6 %
Body TSL temperature during test	(22.5 ± 0.2) °C	---	---

SAR result with Body TSL

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	250 mW input power	2.56 mW / g
SAR normalized	normalized to 1W	10.2 mW / g
SAR for nominal Body TSL parameters ²	normalized to 1W	10.0 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR measured	250 mW input power	1.68 mW / g
SAR normalized	normalized to 1W	6.72 mW / g
SAR for nominal Body TSL parameters ²	normalized to 1W	6.61 mW / g ± 16.5 % (k=2)

² Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	52.3 Ω - 2.5 j Ω
Return Loss	- 29.5 dB

Antenna Parameters with Body TSL

Impedance, transformed to feed point	48.3 Ω - 4.3 j Ω
Return Loss	- 26.6 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.390 ns
----------------------------------	----------

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	October 17, 2008

DASY5 Validation Report for Head TSL

Date/Time: 13.07.2009 11:31:45

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 835 MHz; Type: D835V2; Serial: D835V2 - SN:4d082

Communication System: CW-835; Frequency: 835 MHz; Duty Cycle: 1:1

Medium: HSL 900 MHz

Medium parameters used: $f = 835$ MHz; $\sigma = 0.89$ mho/m; $\epsilon_r = 40.5$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

- Probe: ES3DV2 - SN3025; ConvF(5.86, 5.86, 5.86); Calibrated: 30.04.2009
- Sensor-Surface: 3mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 07.03.2009
- Phantom: Flat Phantom 4.9L; Type: QD000P49AA; Serial: 1001
- Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

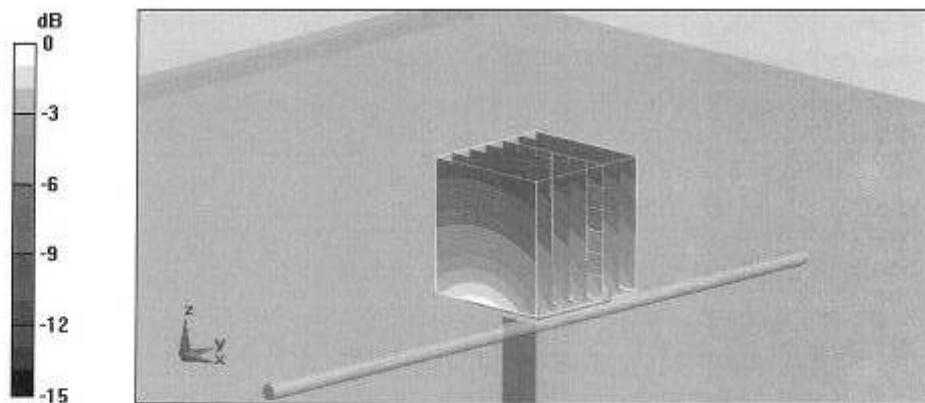
Pin=250mW; dip=15mm/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 57.4 V/m; Power Drift = 0.00639 dB

Peak SAR (extrapolated) = 3.62 W/kg

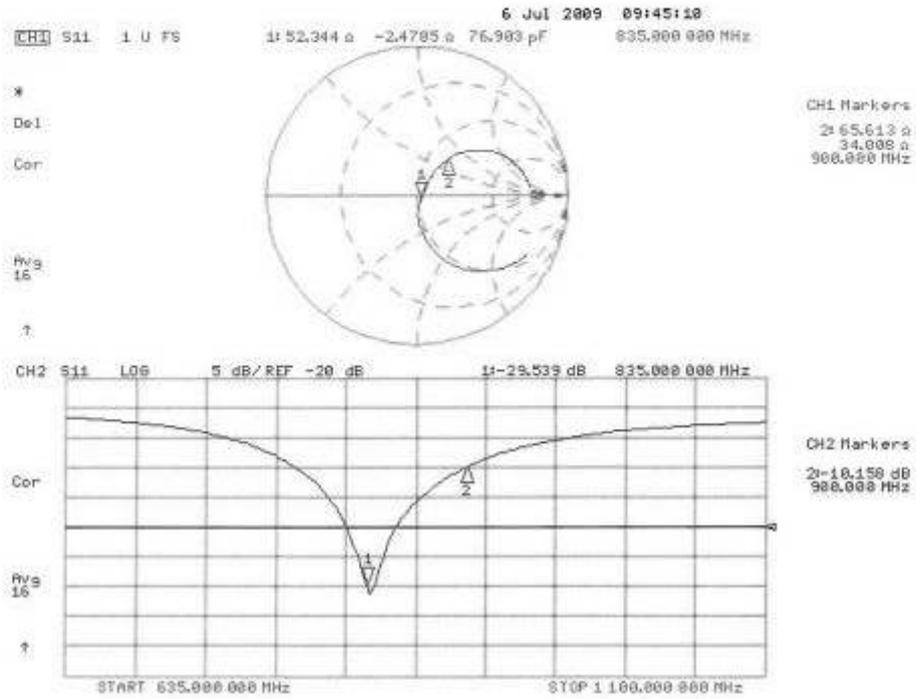
SAR(1 g) = 2.42 mW/g; SAR(10 g) = 1.58 mW/g

Maximum value of SAR (measured) = 2.8 mW/g



0 dB = 2.8mW/g

Impedance Measurement Plot for Head TSL



DASY5 Validation Report for Body TSL

Date/Time: 13.07.2009 11:50:13

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 835 MHz; Type: D835V2; Serial: D835V2 - SN:4d082

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium: MSL900

Medium parameters used: $f = 835$ MHz; $\sigma = 0.99$ mho/m; $\epsilon_r = 53$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

- Probe: ES3DV2 - SN3025; ConvF(5.79, 5.79, 5.79); Calibrated: 30.04.2009
- Sensor-Surface: 3mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 07.03.2009
- Phantom: Flat Phantom 4.9L; Type: QD000P49AA; Serial: 1001
- Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

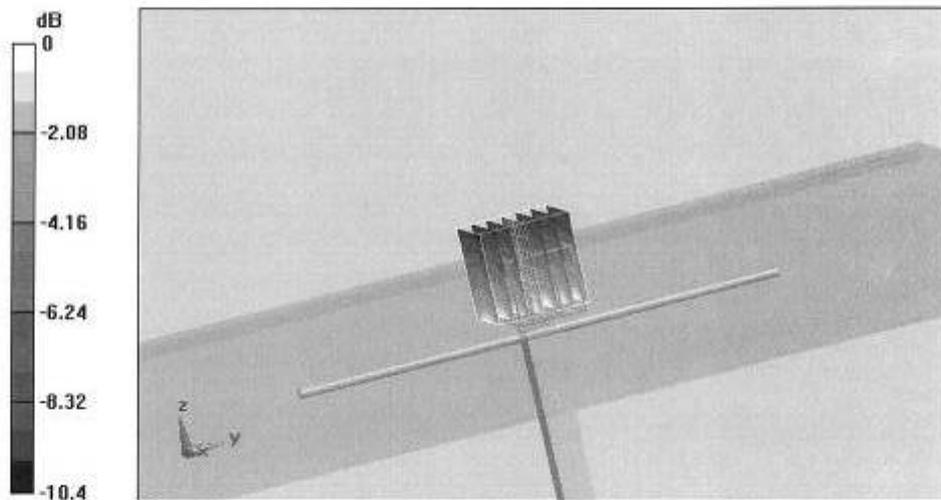
Pin = 250mW, d = 15mm/Zoom Scan (7x7x7)/Cube 0; Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 56.4 V/m; Power Drift = 0.013 dB

Peak SAR (extrapolated) = 3.76 W/kg

SAR(1 g) = 2.56 mW/g; SAR(10 g) = 1.68 mW/g

Maximum value of SAR (measured) = 2.97 mW/g



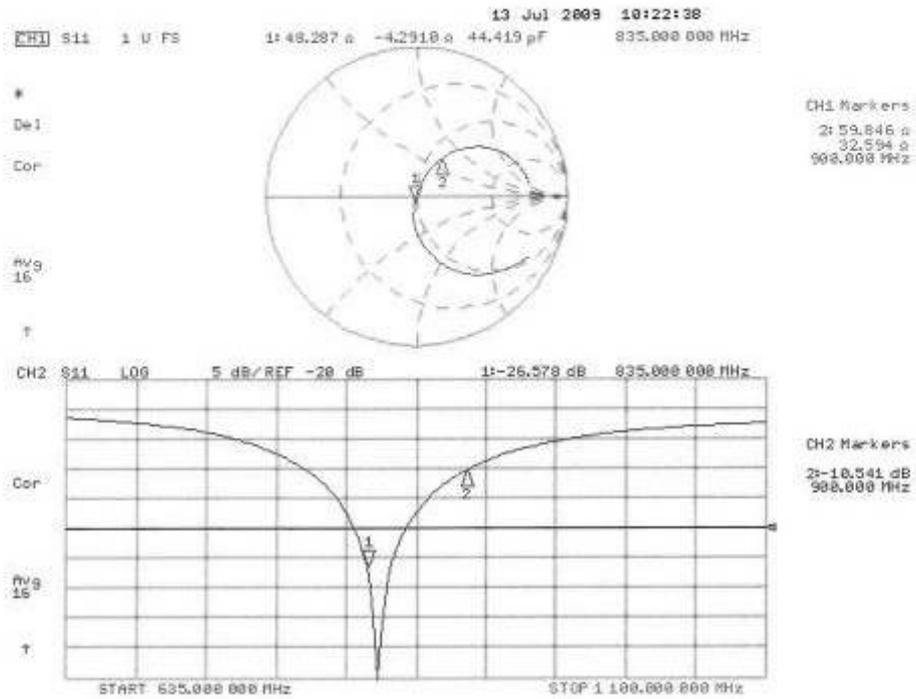
0 dB = 2.97mW/g

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0732

Page 57 of 73

Impedance Measurement Plot for Body TSL



TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0732

Page 58of 73

ANNEX F: D1900V2 Dipole Calibration Certificate

**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
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S Swiss Calibration Service

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The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **Auden**

Certificate No: **D1900V2-5d018-Jun09**

CALIBRATION CERTIFICATE

Object **D1900V2 - SN: 5d018**

Calibration procedure(s) **QA CAL-05.v7
Calibration procedure for dipole validation kits**

Calibration date: **June 26, 2009**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	08-Oct-08 (No. 217-00898)	Oct-09
Power sensor HP 8481A	US37292783	08-Oct-08 (No. 217-00898)	Oct-09
Reference 20 dB Attenuator	SN: 5096 (20g)	31-Mar-09 (No. 217-01025)	Mar-10
Type-N mismatch combination	SN: 5047.2 / 06327	31-Mar-09 (No. 217-01029)	Mar-10
Reference Probe ES3DV2	SN: 3025	30-Apr-09 (No. ES3-3025_Apr09)	Apr-10
DAE4	SN: 601	07-Mar-09 (No. DAE4-601_Mar09)	Mar-10
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (in house check Oct-07)	In house check: Oct-09
RF generator R&S SMT-06	100005	4-Aug-99 (in house check Oct-07)	In house check: Oct-09
Network Analyzer HP 8753E	US37390585 54206	18-Oct-01 (in house check Oct-08)	In house check: Oct-09

Calibrated by:	Name Jeton Kastrot	Function Laboratory Technician	Signature
Approved by:	Name Katja Pokovic	Technical Manager	

Issued: June 29, 2009

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

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Zeughausstrasse 43, 8004 Zurich, Switzerland



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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Glossary:

TSL tissue simulating liquid
ConvF sensitivity in TSL / NORM x,y,z
N/A not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) CENELEC EN 50361, "Basic standard for the measurement of Specific Absorption Rate related to human exposure to electromagnetic fields from mobile phones (300 MHz - 3 GHz), July 2001
- c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

- d) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- *Measurement Conditions:* Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- *Antenna Parameters with TSL:* The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- *Feed Point Impedance and Return Loss:* These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- *Electrical Delay:* One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- *SAR measured:* SAR measured at the stated antenna input power.
- *SAR normalized:* SAR as measured, normalized to an input power of 1 W at the antenna connector.
- *SAR for nominal TSL parameters:* The measured TSL parameters are used to calculate the nominal SAR result.

TA Technology (Shanghai) Co., Ltd. Test Report

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V5.0
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V5.0	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	1900 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	40.0	1.40 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	41.0 ± 6 %	1.42 mho/m ± 6 %
Head TSL temperature during test	(22.0 ± 0.2) °C	----	----

SAR result with Head TSL

SAR averaged over 1 cm³ (1 g) of Head TSL	condition	
SAR measured	250 mW input power	10.3 mW / g
SAR normalized	normalized to 1W	41.2 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	41.1 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm³ (10 g) of Head TSL	Condition	
SAR measured	250 mW input power	5.38 mW / g
SAR normalized	normalized to 1W	21.5 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	21.5 mW / g ± 16.5 % (k=2)

¹ Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

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Body TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	53.3	1.52 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	53.9 ± 6 %	1.55 mho/m ± 6 %
Body TSL temperature during test	(21.2 ± 0.2) °C	-----	-----

SAR result with Body TSL

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	250 mW input power	10.5 mW / g
SAR normalized	normalized to 1W	42.0 mW / g
SAR for nominal Body TSL parameters ²	normalized to 1W	41.7 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR measured	250 mW input power	5.52 mW / g
SAR normalized	normalized to 1W	22.1 mW / g
SAR for nominal Body TSL parameters ²	normalized to 1W	22.0 mW / g ± 16.5 % (k=2)

² Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

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Test Report

Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	51.8 Ω + 2.7 j Ω
Return Loss	- 29.9 dB

Antenna Parameters with Body TSL

Impedance, transformed to feed point	46.6 Ω + 4.3 j Ω
Return Loss	- 24.9 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.195 ns
----------------------------------	----------

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.
No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	June 04, 2002

DASY5 Validation Report for Head TSL

Date/Time: 26.06.2009 13:05:15

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN:5d018

Communication System: CW; Frequency: 1900 MHz; Duty Cycle: 1:1

Medium: HSL U11 BB

Medium parameters used: $f = 1900$ MHz; $\sigma = 1.42$ mho/m; $\epsilon_r = 41$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

- Probe: ES3DV2 - SN3025; ConvF(4.88, 4.88, 4.88); Calibrated: 30.04.2009
- Sensor-Surface: 3mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 07.03.2009
- Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001
- Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

Pin = 250 mW; dip = 10 mm/Zoom Scan (dist=3.0 mm, probe 0deg) (7x7x7)/Cube 0:

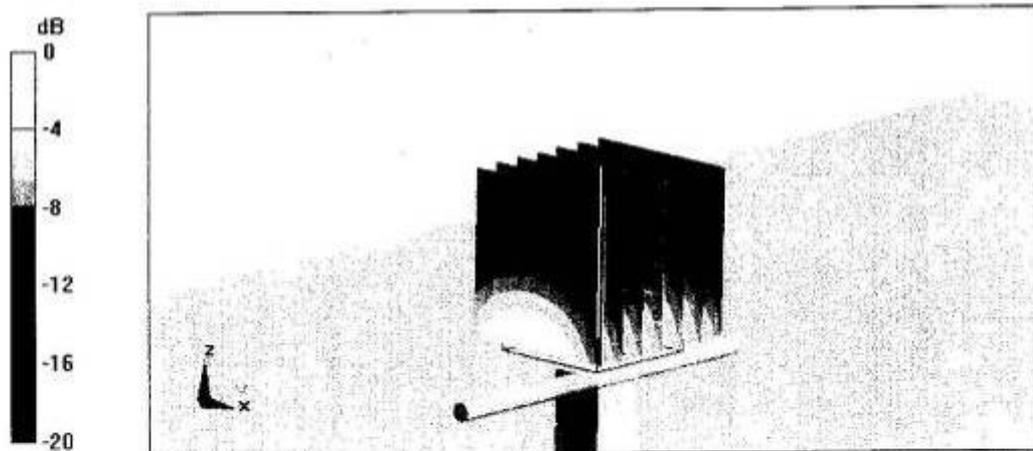
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 97.6 V/m; Power Drift = 0.030 dB

Peak SAR (extrapolated) = 18.7 W/kg

SAR(1 g) = 10.3 mW/g; SAR(10 g) = 5.38 mW/g

Maximum value of SAR (measured) = 12.6 mW/g



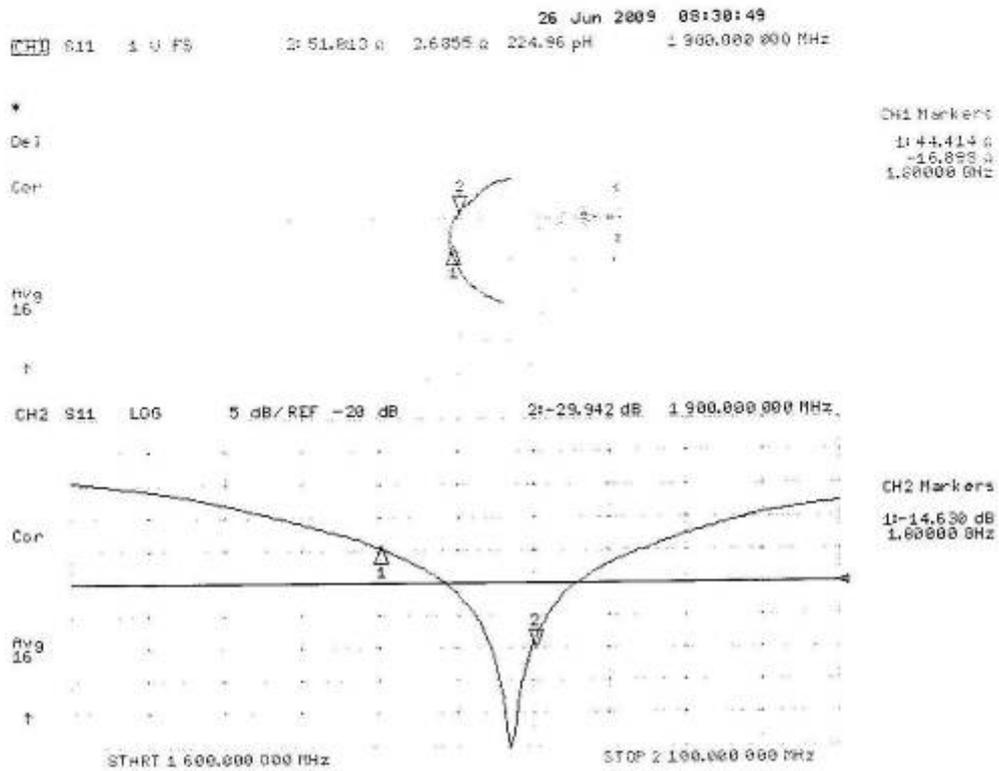
0 dB = 12.6mW/g

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0732

Page 64 of 73

Impedance Measurement Plot for Head TSL



DASY5 Validation Report for Body TSL

Date/Time: 26.06.2009 14:30:50

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN:5d018

Communication System: CW; Frequency: 1900 MHz; Duty Cycle: 1:1

Medium: MSL U10 BB

Medium parameters used: $f = 1900$ MHz; $\sigma = 1.55$ mho/m; $\epsilon_r = 54$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

- Probe: ES3DV2 - SN3025; ConvF(4.46, 4.46, 4.46); Calibrated: 30.04.2009
- Sensor-Surface: 3mm (Mechanical Surface Detection)
- Electronics: DAE4 Sa601; Calibrated: 07.03.2009
- Phantom: Flat Phantom 5.0 (back); Type: QD000P50AA; Serial: 1002
- Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

Pin = 250 mW; dip = 10 mm/Zoom Scan (dist=3.0mm, probe 0deg) (7x7x7)/Cube 0:

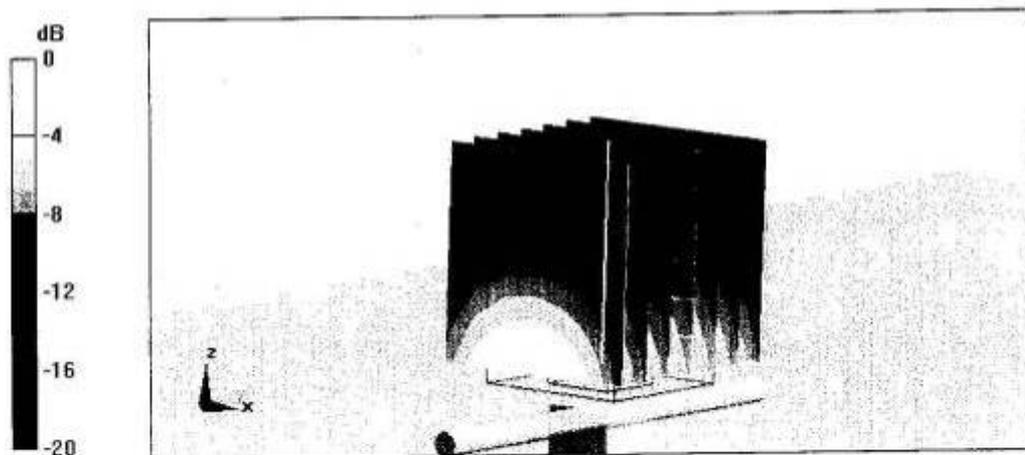
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 95.8 V/m; Power Drift = 0.043 dB

Peak SAR (extrapolated) = 18.9 W/kg

SAR(1 g) = 10.5 mW/g; SAR(10 g) = 5.52 mW/g

Maximum value of SAR (measured) = 13.3 mW/g



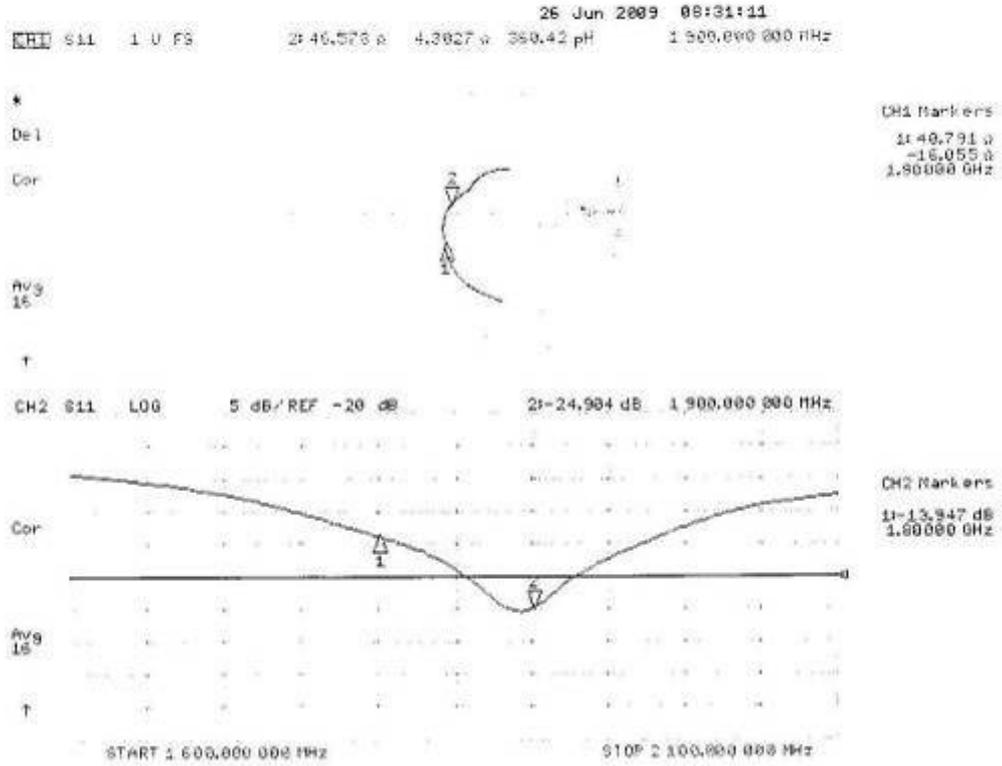
0 dB = 13.3mW/g

TA Technology (Shanghai) Co., Ltd. Test Report

Report No. RZA2010-0732

Page 66of 73

Impedance Measurement Plot for Body TSL



TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA2010-0732

Page 67 of 73

ANNEX G: DAE4 Calibration Certificate

**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **Auden**

Certificate No: **DAE4-905_Jun09**

CALIBRATION CERTIFICATE

Object **DAE4 - SD 000 D04 BK - SN: 905**

Calibration procedure(s) **QA CAL-06.v12
Calibration procedure for the data acquisition electronics (DAE)**

Calibration date: **June 24, 2009**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Fluke Process Calibrator Type 702	SN: 6295803	30-Sep-08 (No: 7673)	Sep-09
Keithley Multimeter Type 2001	SN: 0810278	30-Sep-08 (No: 7670)	Sep-09
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Calibrator Box V1.1	SE UMS 006 AB 1004	05-Jun-09 (in house check)	In house check: Jun-10

Calibrated by:	Name Andrea Guntli	Function Technician	Signature
Approved by:	Name Fin Bomholt	Function R&D Director	Signature

Issued: June 24, 2009

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Calibration Laboratory of
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Zeughausstrasse 43, 8004 Zurich, Switzerland



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S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Glossary

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- *DC Voltage Measurement*: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle*: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - *DC Voltage Measurement Linearity*: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - *Common mode sensitivity*: Influence of a positive or negative common mode voltage on the differential measurement.
 - *Channel separation*: Influence of a voltage on the neighbor channels not subject to an input voltage.
 - *AD Converter Values with inputs shorted*: Values on the internal AD converter corresponding to zero input voltage
 - *Input Offset Measurement*: Output voltage and statistical results over a large number of zero voltage measurements.
 - *Input Offset Current*: Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - *Input resistance*: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - *Low Battery Alarm Voltage*: Typical value for information. Below this voltage, a battery alarm signal is generated.
 - *Power consumption*: Typical value for information. Supply currents in various operating modes.

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RZA2010-0732

Page 69 of 73

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V, full range = -100...+300 mV

Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.217 \pm 0.1% (k=2)	404.768 \pm 0.1% (k=2)	404.344 \pm 0.1% (k=2)
Low Range	3.96064 \pm 0.7% (k=2)	3.96162 \pm 0.7% (k=2)	3.94181 \pm 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	224 \pm 1 $^{\circ}$
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TA Technology (Shanghai) Co., Ltd.

Test Report

Appendix

1. DC Voltage Linearity

High Range	Input (μV)	Reading (μV)	Error (%)
Channel X + Input	200000	199999.8	0.00
Channel X + Input	20000	20006.37	0.03
Channel X - Input	20000	-20001.53	0.01
Channel Y + Input	200000	200000.2	0.00
Channel Y + Input	20000	20007.65	0.04
Channel Y - Input	20000	-20004.14	0.02
Channel Z + Input	200000	199999.8	0.00
Channel Z + Input	20000	20004.62	0.02
Channel Z - Input	20000	-20006.32	0.03

Low Range	Input (μV)	Reading (μV)	Error (%)
Channel X + Input	2000	2000	0.00
Channel X + Input	200	200.19	0.09
Channel X - Input	200	-199.93	-0.03
Channel Y + Input	2000	1999.9	0.00
Channel Y + Input	200	199.73	-0.13
Channel Y - Input	200	-200.49	0.25
Channel Z + Input	2000	2000.1	0.00
Channel Z + Input	200	199.32	-0.34
Channel Z - Input	200	-201.09	0.55

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	8.73	8.55
	-200	-8.62	-8.40
Channel Y	200	8.12	8.42
	-200	-9.55	-9.70
Channel Z	200	1.20	1.94
	-200	-3.81	-3.79

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	0.64	-0.52
Channel Y	200	0.59	-	3.21
Channel Z	200	-0.99	-1.28	-

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Test Report

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15874	16893
Channel Y	16121	14432
Channel Z	16378	17173

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec
Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	0.28	-0.63	1.52	0.30
Channel Y	-0.58	-1.70	1.19	0.27
Channel Z	-0.85	-2.59	0.78	0.43

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.1999	200.7
Channel Y	0.1999	199.0
Channel Z	0.1999	199.7

8. Low Battery Alarm Voltage (verified during pre test)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	-0.01	-8	-9